

TPS22958x 5.5-V, 4-A / 6-A, 14-mΩ Load Switch with Adjustable Rise Time

1 Features

- Integrated N-Channel Load Switch
- Input Voltage Range: 0.6 V to 5.5 V
- VBIAS Voltage Range: 2.5 V to 5.5 V
- R_{ON} Resistance
 - $R_{ON} = 14\text{ m}\Omega$ at $V_{IN} = 5\text{ V}$ ($V_{BIAS} = 5\text{ V}$)
 - $R_{ON} = 13\text{ m}\Omega$ at $V_{IN} = 3.3\text{ V}$ ($V_{BIAS} = 5\text{ V}$)
 - $R_{ON} = 13\text{ m}\Omega$ at $V_{IN} = 1.8\text{ V}$ ($V_{BIAS} = 5\text{ V}$)
- 4 A Maximum Continuous Switch Current (DGK Package)
- 6 A Maximum Continuous Switch Current (DGN Package)
- Low Quiescent Current
 - $55\text{ }\mu\text{A}$ at $V_{BIAS} = 5\text{ V}$
- Low Control Input Threshold Enables Use of 1.2 V/1.8 V/2.5 V/3.3 V Logic
- Adjustable Rise Time⁽¹⁾
- Quick Output Discharge (QOD)⁽²⁾
- DGK 8-Pin Package:
 - 3.0 mm x 4.9 mm x 1.1 mm and 0.65 mm pitch
- DGN 8-Pin Package with Thermal Pad:
 - 3.0 mm x 4.9 mm x 1.1 mm and 0.65 mm pitch
- ESD Performance Tested per JEDEC STD.
 - 2-kV HBM and 1-kV CDM
- Latch-Up Performance Exceeds 100 mA per JESD 78, Class II
- GPIO Enable – Active High

(1) See [Adjustable Rise Time](#) section for CT value vs. rise time

(2) Not featured in the TPS22958N device.

2 Applications

- EPOS
- Factory Automation/Control
- Building Automation
- Printers
- Wave Soldering Manufacturing

3 Description

The TPS22958x is a small, single channel load switch with an adjustable rise time. The device contains an N-Channel MOSFET that can operate over an input voltage range of 0.6 V to 5.5 V and can support a maximum continuous current of 4 A (DGK package) or 6 A (DGN package). The switch is controlled by an on/off input, which is capable of interfacing directly with low voltage control signals.

The rise time of the device can be externally controlled in order to avoid inrush current. Attaching a capacitor to the CT pin will change the rise time: increasing the value of the capacitor will increase the rise time. The TPS22958x is available in two space-saving packages (DGK and DGN) with or without a thermal pad for high power dissipation. The device is characterized for operation over the free-air temperature range of -40°C to 105°C .

Device Information⁽¹⁾

PART NUMBER	PACKAGE (PIN)	BODY SIZE (NOM)
TPS22958x	DGK (8)	3.00 mm x 4.90 mm
	DGN (8)	3.00 mm x 4.90 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Typical Application Schematic

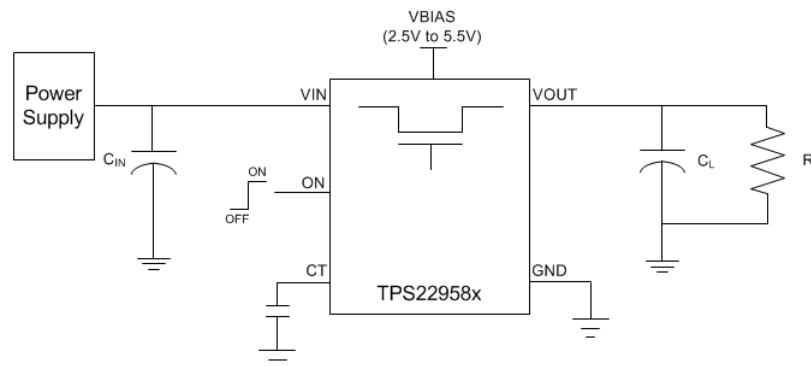


Table of Contents

1	Features	1	9	Detailed Description	17
2	Applications	1	9.1	Overview	17
3	Description	1	9.2	Functional Block Diagram	17
4	Revision History	2	9.3	Feature Description	17
5	Device Comparison Table	3	9.4	Device Functional Modes	19
6	Pin Configuration and Functions	3	10	Application and Implementation	20
7	Specifications	4	10.1	Application Information	20
7.1	Absolute Maximum Ratings	4	10.2	Typical Application	21
7.2	ESD Ratings	4	11	Power Supply Recommendations	24
7.3	Recommended Operating Conditions	4	12	Layout	24
7.4	Thermal Information	5	12.1	Layout Guidelines	24
7.5	Electrical Characteristics ($V_{BIAS} = 5\text{ V}$)	6	12.2	Layout Example	25
7.6	Electrical Characteristics ($V_{BIAS} = 3.3\text{ V}$)	7	13	Device and Documentation Support	26
7.7	Electrical Characteristics ($V_{BIAS} = 2.5\text{ V}$)	8	13.1	Related Links	26
7.8	Switching Characteristics	9	13.2	Trademarks	26
7.9	Typical DC Characteristics	10	13.3	Electrostatic Discharge Caution	26
7.10	Typical AC Characteristics	13	13.4	Glossary	26
8	Parameter Measurement Information	16	14	Mechanical, Packaging, and Orderable Information	26

4 Revision History

Changes from Original (January 2014) to Revision A

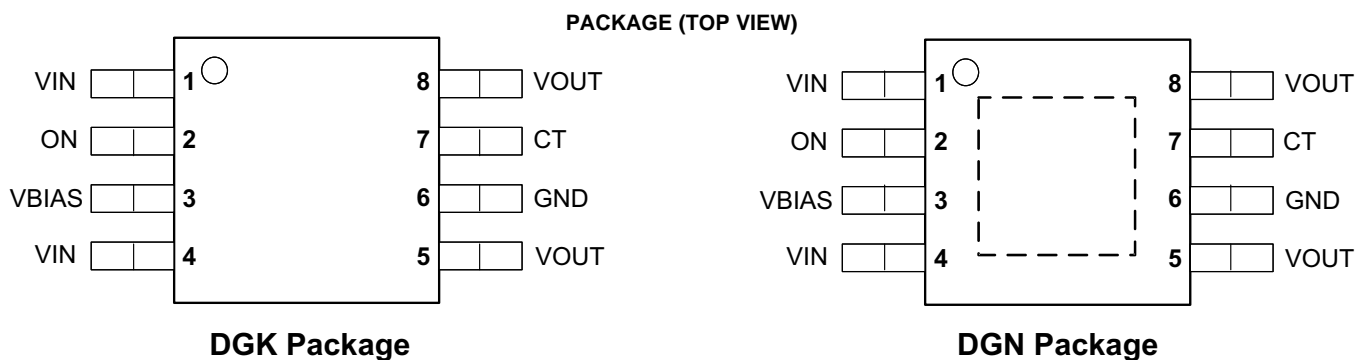
Page

•	Initial release of full version.	1
---	---------------------------------------	---

5 Device Comparison Table

DEVICE	R_{ON} AT VIN = VBIAS = 5V	RISE TIME	QUICK OUTPUT DISCHARGE	MAX OUTPUT CURRENT	ENABLE
TPS22958DGK	14 mΩ	Adjustable	Yes	4 A	Active High
TPS22958DGN		Adjustable	Yes	6 A	
TPS22958NDGK		Adjustable	No	4 A	
TPS22958NDGN		Adjustable	No	6 A	

6 Pin Configuration and Functions



Pin Functions

PIN		I/O	DESCRIPTION
NO.	NAME		
1, 4	VIN	I	Switch input. Bypass this input with a ceramic capacitor to GND. These pins should be tied together as shown in Layout Information.
2	ON	I	Active-high switch control input. Do not leave floating.
3	VBIAS	I	Bias voltage. Power supply to the device. Recommended voltage range for this pin is 2.5 to 5.5 V. See VIN and VBIAS Voltage Range .
5, 8	VOUT	O	Switch output
6	GND	—	Ground
7	CT	O	Switch slew rate control. Can be left floating.
—	Thermal Pad ⁽¹⁾	—	Thermal pad (exposed center pad) to alleviate thermal stress. Tie to GND. See Layout Guidelines for layout guidelines.

(1) Only available for the DGN package

7 Specifications

7.1 Absolute Maximum Ratings

Over operating free-air temperature (unless otherwise noted)⁽¹⁾ ⁽²⁾

		MIN	MAX	UNIT
V _{IN}	Input voltage	-0.3	6	V
V _{BIAS}	Bias voltage	-0.3	6	V
V _{OUT}	Output voltage	-0.3	6	V
V _{ON}	ON voltage	-0.3	6	V
I _{MAX}	Maximum continuous switch current, T _A = 65°C (DGK Package)		4	A
	Maximum continuous switch current, T _A = 75°C (DGN Package)		6	A
I _{PLS}	Maximum pulsed switch current, pulse <300 μs, 2% duty cycle (DGK Package)		6	A
	Maximum pulsed switch current, pulse <300 μs, 2% duty cycle (DGN Package)		8	A
T _J	Maximum junction temperature		125	°C
T _{stg}	Storage temperature range	-65	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values are with respect to network ground terminal.

7.2 ESD Ratings

		VALUE	UNIT
V _(ESD)	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000
		Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±1000

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process. Manufacturing with less than 500-V HBM is possible with the necessary precautions.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process. Manufacturing with less than 250-V CDM is possible with the necessary precautions.

7.3 Recommended Operating Conditions

			MIN	MAX	UNIT
V _{IN}	Input voltage range		0.6	V _{BIAS}	V
V _{BIAS}	Bias voltage range		2.5	5.5	V
V _{ON}	ON voltage range		0	5.5	V
V _{OUT}	Output voltage range			V _{IN}	V
V _{IH, ON}	High-level input voltage, ON	V _{BIAS} = 2.5 to 5.5 V	1.2	5.5	V
V _{IL, ON}	Low-level input voltage, ON	V _{BIAS} = 2.5 to 5.5 V	0	0.5	V
T _A	Operating free-air temperature ⁽¹⁾		-40	105	°C
C _{IN}	Input capacitor		1 ⁽²⁾		μF

- (1) In applications where high power dissipation and/or poor package thermal resistance is present, the maximum ambient temperature may have to be derated. Maximum ambient temperature [T_{A(max)}] is dependent on the maximum operating junction temperature [T_{J(max)}], the maximum power dissipation of the device in the application [P_{D(max)}], and the junction-to-ambient thermal resistance of the part/package in the application (R_{θJA}), as given by the following equation: T_{A(max)} = T_{J(max)} - (R_{θJA} × P_{D(max)}).
- (2) Refer to the [Application Information](#) section.

7.4 Thermal Information

THERMAL METRIC ⁽¹⁾ ⁽²⁾		TPS22958x		UNIT
		DGK (8 PINS)	DGN (8 PINS)	
R _{θJA}	Junction-to-ambient thermal resistance	185.7	67.0	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance	77.3	66.5	
R _{θJB}	Junction-to-board thermal resistance	107.0	46.8	
Ψ _{JT}	Junction-to-top characterization parameter	15.2	5.0	
Ψ _{JB}	Junction-to-board characterization parameter	105.4	46.6	
R _{θJC(bot)}	Junction-to-case (bottom) thermal resistance	n/a	14.9	

- (1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, [SPRA953](#).
 (2) For thermal estimates of this device based on PCB copper area, see the *TI PCB Thermal Calculator*.

7.5 Electrical Characteristics ($V_{BIAS} = 5\text{ V}$)

Unless otherwise noted, the specification in the following table applies over the operating ambient temperature $-40^{\circ}\text{C} \leq T_A \leq 105^{\circ}\text{C}$ and $V_{BIAS} = 5\text{ V}$. Typical values are for $T_A = 25^{\circ}\text{C}$ (unless otherwise noted).

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT		
POWER SUPPLIES AND CURRENTS									
I_Q, V_{BIAS}	V_{BIAS} quiescent current	$I_{OUT} = 0, V_{IN} = V_{ON} = V_{BIAS} = 5\text{ V}$	-40°C to 85°C	54	60		μA		
			-40°C to 105°C		60				
I_{SD}, V_{BIAS}	V_{BIAS} shutdown current	$V_{ON} = 0\text{ V}, V_{OUT} = 0\text{ V}, V_{BIAS} = 5\text{ V}$	-40°C to 85°C	0.5	1		μA		
			-40°C to 105°C		1				
I_{SD}, V_{IN}	V_{IN} shutdown current	$V_{ON} = 0\text{ V}, V_{OUT} = 0\text{ V}, V_{BIAS} = 5\text{ V}$	$V_{IN} = 5\text{ V}$	-40°C to 85°C	0.5	8	μA		
				-40°C to 105°C		10			
			$V_{IN} = 3.3\text{ V}$	-40°C to 85°C	0.1	3			
				-40°C to 105°C		4			
			$V_{IN} = 1.8\text{ V}$	-40°C to 85°C	0.07	2			
				-40°C to 105°C		3			
			$V_{IN} = 1.2\text{ V}$	-40°C to 85°C	0.05	1			
				-40°C to 105°C		2			
$V_{IN} = 0.6\text{ V}$	-40°C to 85°C	0.04	1						
	-40°C to 105°C		2						
I_{ON}	ON pin input leakage current	$V_{ON} = 5.5\text{ V}, V_{BIAS} = 5\text{ V}$	-40°C to 105°C		0.1	μA			
RESISTANCE CHARACTERISTICS									
R_{ON}	ON-state resistance	$I_{OUT} = -200\text{ mA}, V_{BIAS} = 5\text{ V}$	$V_{IN} = 5\text{ V}$	25°C	14	18	$\text{m}\Omega$		
				-40°C to 85°C		20			
				-40°C to 105°C		24			
			$V_{IN} = 3.3\text{ V}$	25°C	13	17	$\text{m}\Omega$		
				-40°C to 85°C		20			
				-40°C to 105°C		23			
			$V_{IN} = 2.5\text{ V}$	25°C	13	17	$\text{m}\Omega$		
				-40°C to 85°C		20			
				-40°C to 105°C		23			
			$V_{IN} = 1.8\text{ V}$	25°C	13	17	$\text{m}\Omega$		
				-40°C to 85°C		20			
				-40°C to 105°C		23			
			$V_{IN} = 1.5\text{ V}$	25°C	13	17	$\text{m}\Omega$		
				-40°C to 85°C		20			
				-40°C to 105°C		23			
			$V_{IN} = 1.2\text{ V}$	25°C	13	17	$\text{m}\Omega$		
				-40°C to 85°C		20			
				-40°C to 105°C		23			
			$V_{IN} = 0.6\text{ V}$	25°C	13	17	$\text{m}\Omega$		
				-40°C to 85°C		20			
				-40°C to 105°C		23			
			R_{PD}	Output pulldown resistance	$V_{IN} = V_{BIAS} = 5\text{ V}, V_{ON} = 0\text{ V}, I_{OUT} = 10\text{ mA}$	-40°C to 105°C	135	160	Ω

7.6 Electrical Characteristics ($V_{BIAS} = 3.3\text{ V}$)

Unless otherwise noted, the specification in the following table applies over the operating ambient temperature $-40^{\circ}\text{C} \leq T_A \leq 105^{\circ}\text{C}$ and $V_{BIAS} = 3.3\text{ V}$. Typical values are for $T_A = 25^{\circ}\text{C}$ (unless otherwise noted).

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT	
POWER SUPPLIES AND CURRENTS								
I_Q, V_{BIAS}	V_{BIAS} quiescent current	$I_{OUT} = 0, V_{IN} = V_{ON} = V_{BIAS} = 3.3\text{ V}$	-40°C to 85°C	23	27		μA	
			-40°C to 105°C			27		
I_{SD}, V_{BIAS}	V_{BIAS} shutdown current	$V_{ON} = 0\text{ V}, V_{OUT} = 0\text{ V}, V_{BIAS} = 3.3\text{ V}$	-40°C to 85°C	0.3	0.7		μA	
			-40°C to 105°C			0.7		
I_{SD}, V_{IN}	V_{IN} shutdown current	$V_{ON} = 0\text{ V}, V_{OUT} = 0\text{ V}, V_{BIAS} = 3.3\text{ V}$	$V_{IN} = 3.3\text{ V}$	-40°C to 85°C	0.1	3	μA	
				-40°C to 105°C				4
			$V_{IN} = 1.8\text{ V}$	-40°C to 85°C	0.07	2		
				-40°C to 105°C				3
			$V_{IN} = 1.2\text{ V}$	-40°C to 85°C	0.05	1		
				-40°C to 105°C				2
$V_{IN} = 0.6\text{ V}$	-40°C to 85°C	0.04	1					
	-40°C to 105°C			2				
I_{ON}	ON pin input leakage current	$V_{ON} = 5.5\text{ V}, V_{BIAS} = 3.3\text{ V}$	-40°C to 105°C			0.1	μA	
RESISTANCE CHARACTERISTICS								
R_{ON}	ON-state resistance	$I_{OUT} = -200\text{ mA}, V_{BIAS} = 3.3\text{ V}$	$V_{IN} = 3.3\text{ V}$	25°C	14	18	$\text{m}\Omega$	
				-40°C to 85°C				20
				-40°C to 105°C				24
			$V_{IN} = 2.5\text{ V}$	25°C	13	17	$\text{m}\Omega$	
				-40°C to 85°C				20
				-40°C to 105°C				23
			$V_{IN} = 1.8\text{ V}$	25°C	13	17	$\text{m}\Omega$	
				-40°C to 85°C				20
				-40°C to 105°C				23
			$V_{IN} = 1.5\text{ V}$	25°C	13	17	$\text{m}\Omega$	
				-40°C to 85°C				20
				-40°C to 105°C				23
			$V_{IN} = 1.2\text{ V}$	25°C	13	17	$\text{m}\Omega$	
				-40°C to 85°C				20
				-40°C to 105°C				23
			$V_{IN} = 0.6\text{ V}$	25°C	13	17	$\text{m}\Omega$	
				-40°C to 85°C				20
				-40°C to 105°C				23
R_{PD}	Output pulldown resistance	$V_{IN} = V_{BIAS} = 3.3\text{ V}, V_{ON} = 0\text{ V}, I_{OUT} = 10\text{ mA}$	-40°C to 105°C	135	160		Ω	

7.7 Electrical Characteristics ($V_{BIAS} = 2.5\text{ V}$)

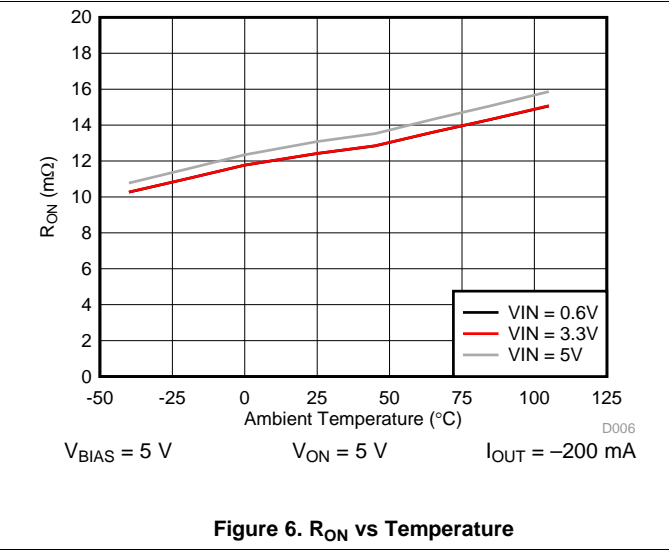
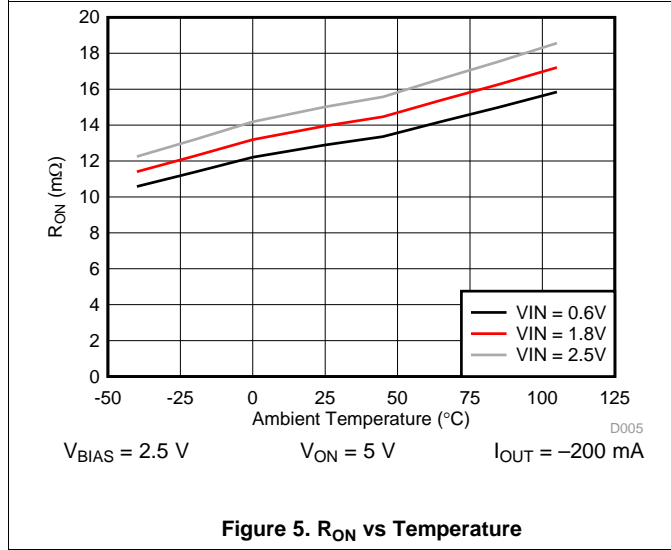
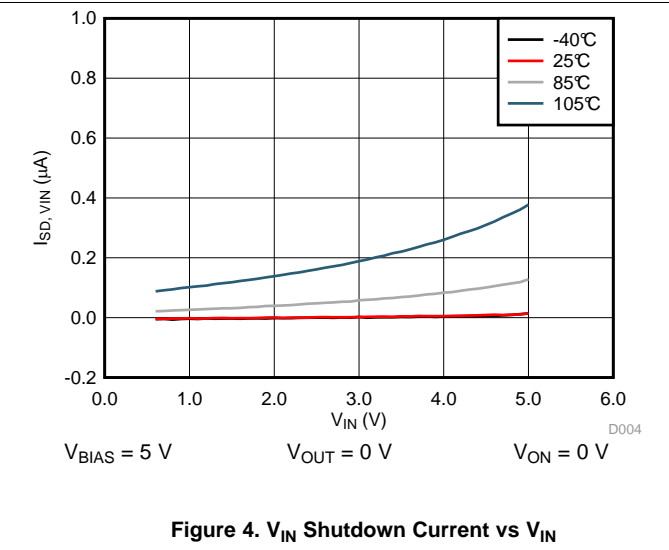
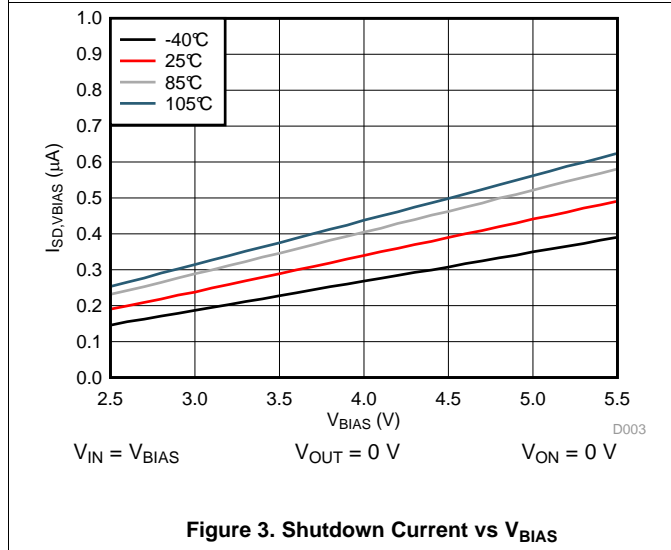
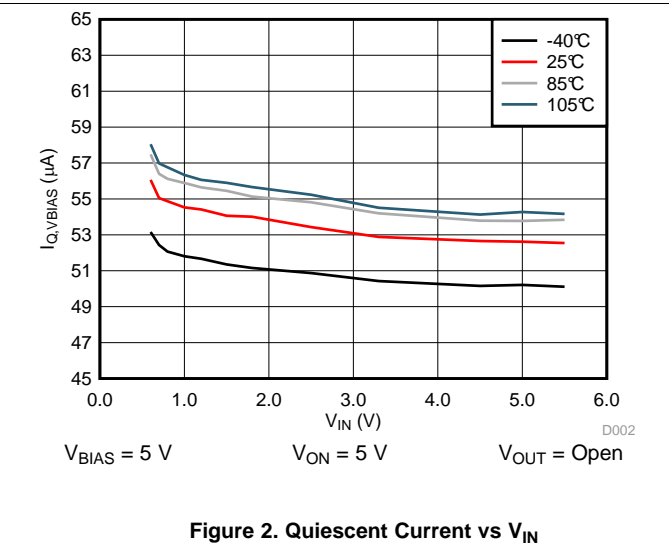
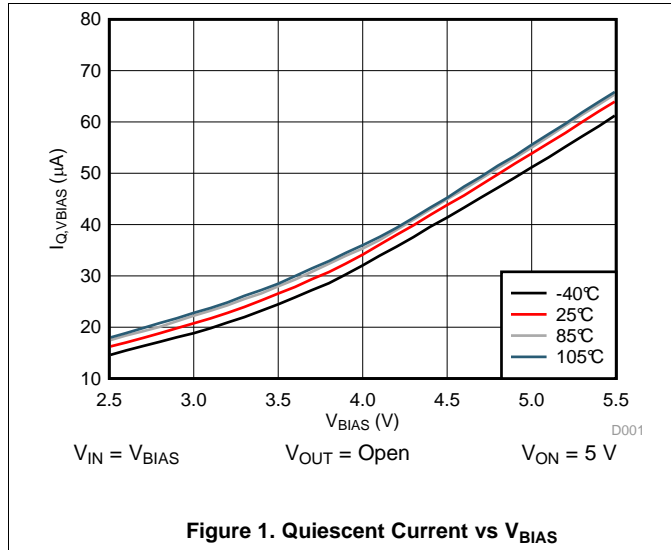
Unless otherwise noted, the specification in the following table applies over the operating ambient temperature $-40\text{ }^{\circ}\text{C} \leq T_A \leq 105\text{ }^{\circ}\text{C}$ and $V_{BIAS} = 2.5\text{ V}$. Typical values are for $T_A = 25\text{ }^{\circ}\text{C}$ (unless otherwise noted).

PARAMETER		TEST CONDITIONS	T_A	MIN	TYP	MAX	UNIT	
POWER SUPPLIES AND CURRENTS								
I_Q, V_{BIAS}	V_{BIAS} quiescent current	$I_{OUT} = 0, V_{IN} = V_{ON} = V_{BIAS} = 2.5\text{ V}$	-40°C to 85°C	14	17		μA	
			-40°C to 105°C			17		
I_{SD}, V_{BIAS}	V_{BIAS} shutdown current	$V_{ON} = 0\text{ V}, V_{OUT} = 0\text{ V}, V_{BIAS} = 2.5\text{ V}$	-40°C to 85°C	0.2	0.5		μA	
			-40°C to 105°C			0.5		
I_{SD}, V_{IN}	V_{IN} shutdown current (per channel)	$V_{ON} = 0\text{ V}, V_{OUT} = 0\text{ V}, V_{BIAS} = 2.5\text{ V}$	$V_{IN} = 2.5\text{ V}$	-40°C to 85°C	0.1	3	μA	
				-40°C to 105°C				4
			$V_{IN} = 1.8\text{ V}$	-40°C to 85°C	0.07	2		
				-40°C to 105°C				3
			$V_{IN} = 1.2\text{ V}$	-40°C to 85°C	0.05	1		
				-40°C to 105°C				2
$V_{IN} = 0.6\text{ V}$	-40°C to 85°C	0.04	1					
	-40°C to 105°C			2				
I_{ON}	ON pin input leakage current	$V_{ON} = 5.5\text{ V}, V_{BIAS} = 2.5\text{ V}$	-40°C to 105°C			0.1	μA	
RESISTANCE CHARACTERISTICS								
R_{ON}	ON-state resistance	$I_{OUT} = -200\text{ mA}, V_{BIAS} = 2.5\text{ V}$	$V_{IN} = 2.5\text{ V}$	25°C	15	19	$\text{m}\Omega$	
				-40°C to 85°C				23
				-40°C to 105°C				26
			$V_{IN} = 1.8\text{ V}$	25°C	14	18	$\text{m}\Omega$	
				-40°C to 85°C				22
				-40°C to 105°C				25
			$V_{IN} = 1.5\text{ V}$	25°C	14	18	$\text{m}\Omega$	
				-40°C to 85°C				22
				-40°C to 105°C				25
			$V_{IN} = 1.2\text{ V}$	25°C	14	18	$\text{m}\Omega$	
				-40°C to 85°C				22
				-40°C to 105°C				25
$V_{IN} = 0.6\text{ V}$	25°C	13	18	$\text{m}\Omega$				
	-40°C to 85°C				22			
	-40°C to 105°C				25			
R_{PD}	Output pulldown resistance	$V_{IN} = V_{BIAS} = 2.5\text{ V}, V_{ON} = 0\text{ V}, I_{OUT} = 10\text{ mA}$	-40°C to 105°C	135	160		Ω	

7.8 Switching Characteristics

PARAMETER		TEST CONDITION	MIN	TYP	MAX	UNIT
$V_{IN} = V_{ON} = V_{BIAS} = 5\text{ V}$, $T_A = 25\text{ }^\circ\text{C}$						
t_{ON}	Turn-on time	$R_L = 10\ \Omega$, $C_L = 0.1\ \mu\text{F}$, $CT = 1000\ \text{pF}$		646		μs
t_{OFF}	Turn-off time	$R_L = 10\ \Omega$, $C_L = 0.1\ \mu\text{F}$, $CT = 1000\ \text{pF}$		5		
t_R	V_{OUT} rise time	$R_L = 10\ \Omega$, $C_L = 0.1\ \mu\text{F}$, $CT = 1000\ \text{pF}$		769		
t_F	V_{OUT} fall time	$R_L = 10\ \Omega$, $C_L = 0.1\ \mu\text{F}$, $CT = 1000\ \text{pF}$		2		
t_D	ON delay time	$R_L = 10\ \Omega$, $C_L = 0.1\ \mu\text{F}$, $CT = 1000\ \text{pF}$		280		
$V_{IN} = 0.6\ \text{V}$, $V_{ON} = V_{BIAS} = 5\ \text{V}$, $T_A = 25\text{ }^\circ\text{C}$						
t_{ON}	Turn-on time	$R_L = 10\ \Omega$, $C_L = 0.1\ \mu\text{F}$, $CT = 1000\ \text{pF}$		303		μs
t_{OFF}	Turn-off time	$R_L = 10\ \Omega$, $C_L = 0.1\ \mu\text{F}$, $CT = 1000\ \text{pF}$		91		
t_R	V_{OUT} rise time	$R_L = 10\ \Omega$, $C_L = 0.1\ \mu\text{F}$, $CT = 1000\ \text{pF}$		126		
t_F	V_{OUT} fall time	$R_L = 10\ \Omega$, $C_L = 0.1\ \mu\text{F}$, $CT = 1000\ \text{pF}$		7		
t_D	ON delay time	$R_L = 10\ \Omega$, $C_L = 0.1\ \mu\text{F}$, $CT = 1000\ \text{pF}$		243		
$V_{IN} = 2.5\ \text{V}$, $V_{ON} = 5\ \text{V}$, $V_{BIAS} = 2.5\ \text{V}$, $T_A = 25\text{ }^\circ\text{C}$						
t_{ON}	Turn-on time	$R_L = 10\ \Omega$, $C_L = 0.1\ \mu\text{F}$, $CT = 1000\ \text{pF}$		983		μs
t_{OFF}	Turn-off time	$R_L = 10\ \Omega$, $C_L = 0.1\ \mu\text{F}$, $CT = 1000\ \text{pF}$		7		
t_R	V_{OUT} rise time	$R_L = 10\ \Omega$, $C_L = 0.1\ \mu\text{F}$, $CT = 1000\ \text{pF}$		987		
t_F	V_{OUT} fall time	$R_L = 10\ \Omega$, $C_L = 0.1\ \mu\text{F}$, $CT = 1000\ \text{pF}$		2		
t_D	ON delay time	$R_L = 10\ \Omega$, $C_L = 0.1\ \mu\text{F}$, $CT = 1000\ \text{pF}$		518		
$V_{IN} = 0.6\ \text{V}$, $V_{ON} = 5\ \text{V}$, $V_{BIAS} = 2.5\ \text{V}$, $T_A = 25\text{ }^\circ\text{C}$						
t_{ON}	Turn-on time	$R_L = 10\ \Omega$, $C_L = 0.1\ \mu\text{F}$, $CT = 1000\ \text{pF}$		611		μs
t_{OFF}	Turn-off time	$R_L = 10\ \Omega$, $C_L = 0.1\ \mu\text{F}$, $CT = 1000\ \text{pF}$		77		
t_R	V_{OUT} rise time	$R_L = 10\ \Omega$, $C_L = 0.1\ \mu\text{F}$, $CT = 1000\ \text{pF}$		305		
t_F	V_{OUT} fall time	$R_L = 10\ \Omega$, $C_L = 0.1\ \mu\text{F}$, $CT = 1000\ \text{pF}$		7		
t_D	ON delay time	$R_L = 10\ \Omega$, $C_L = 0.1\ \mu\text{F}$, $CT = 1000\ \text{pF}$		468		

7.9 Typical DC Characteristics



Typical DC Characteristics (continued)

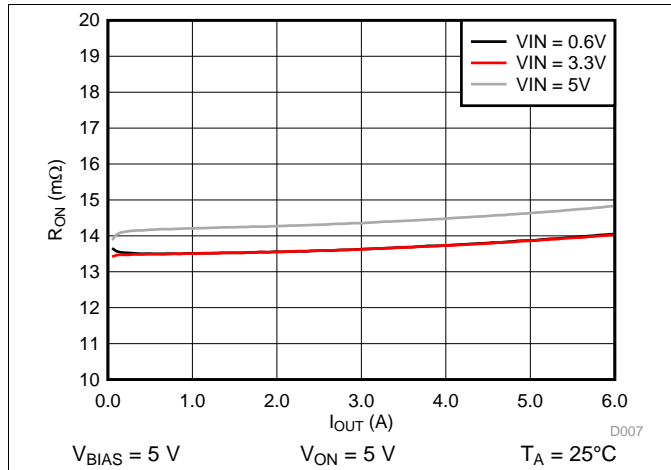


Figure 7. R_{ON} vs I_{OUT} (DGN Package)

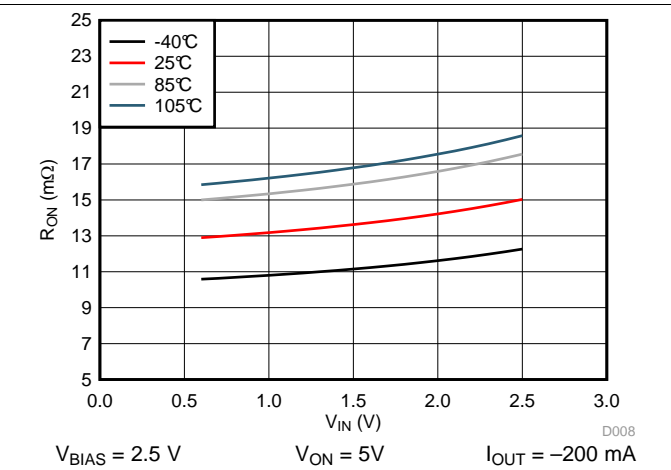


Figure 8. R_{ON} vs V_{IN}

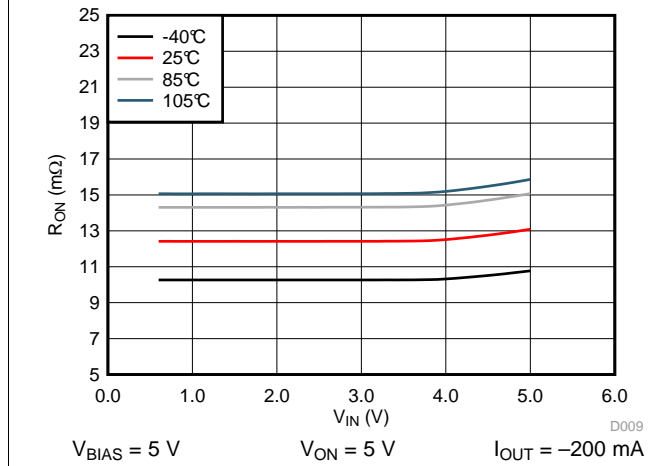


Figure 9. R_{ON} vs V_{IN}

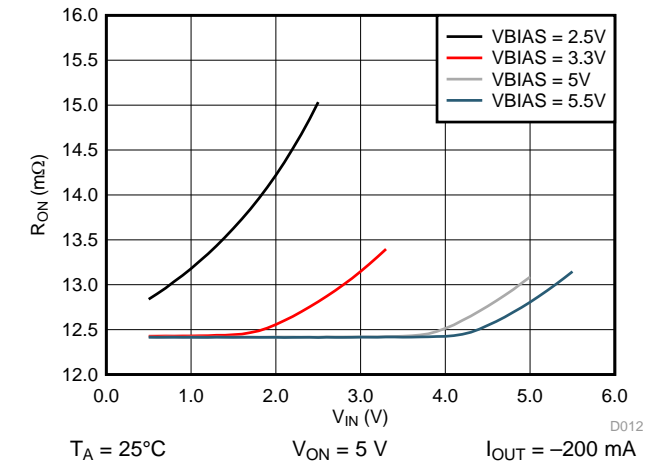


Figure 10. R_{ON} vs V_{IN}

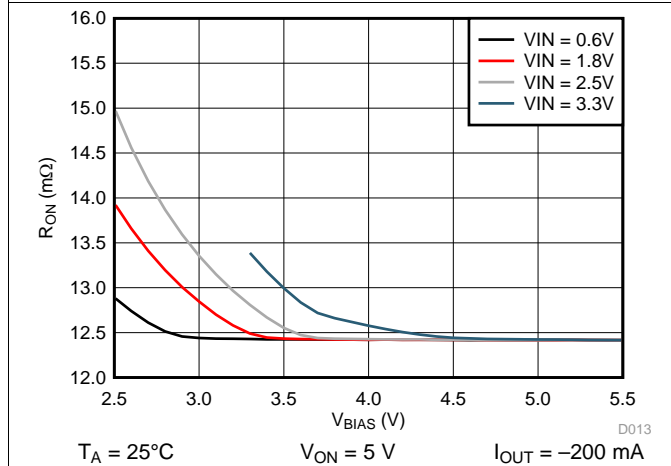


Figure 11. R_{ON} vs V_{BIAS}

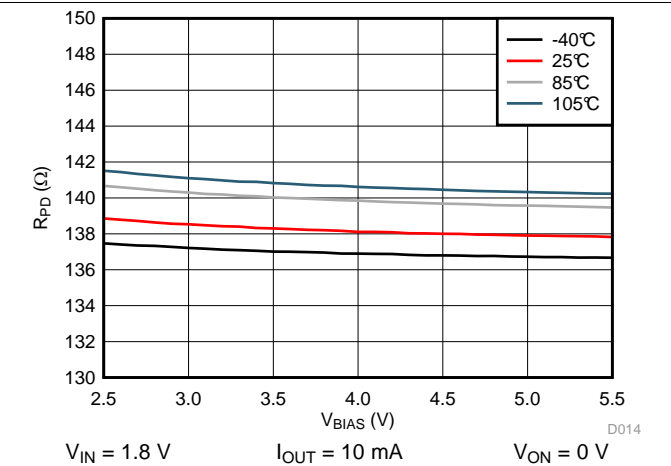
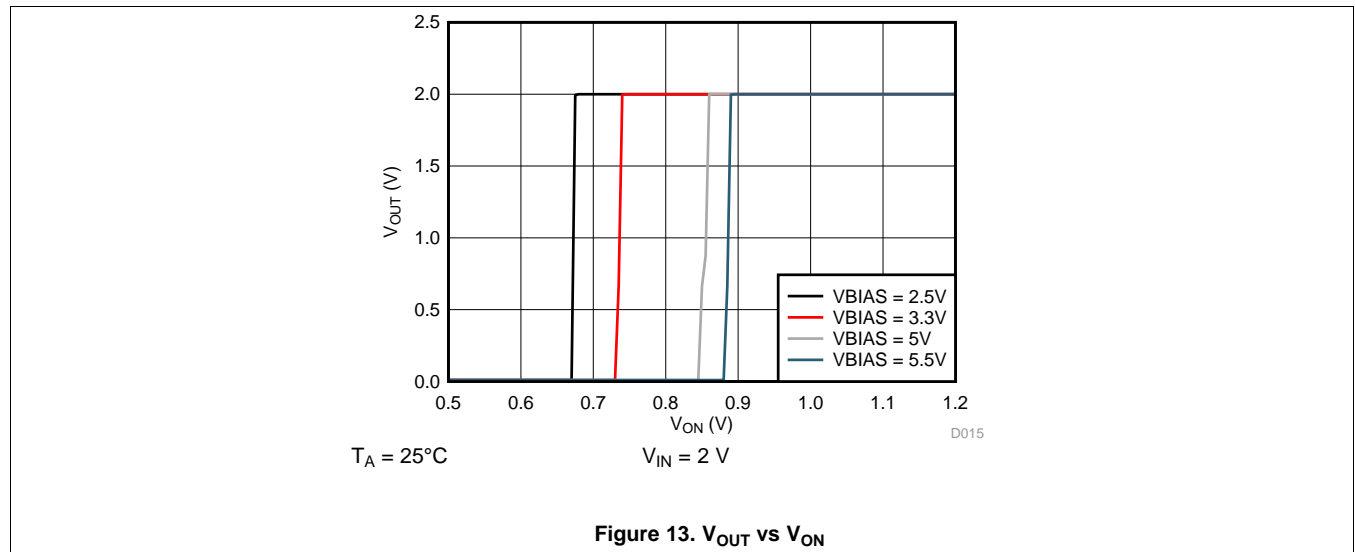


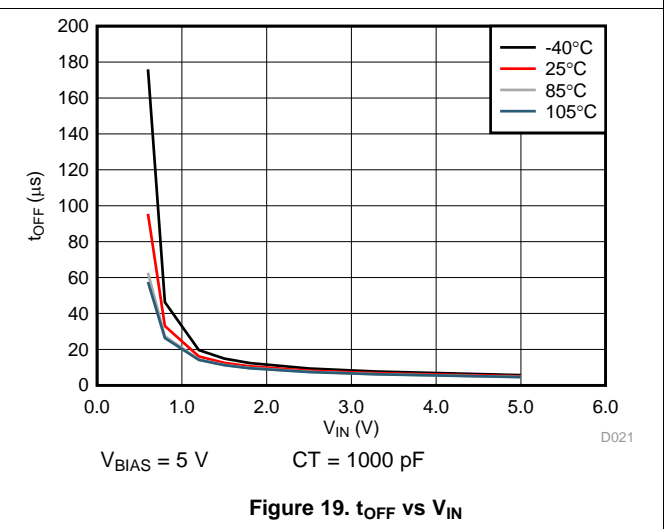
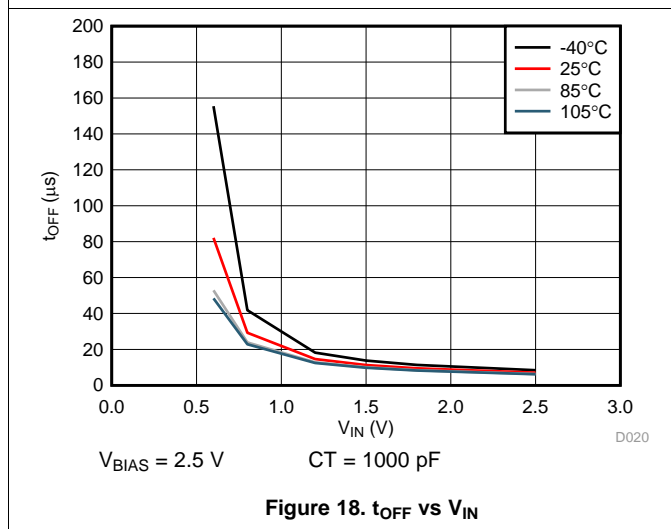
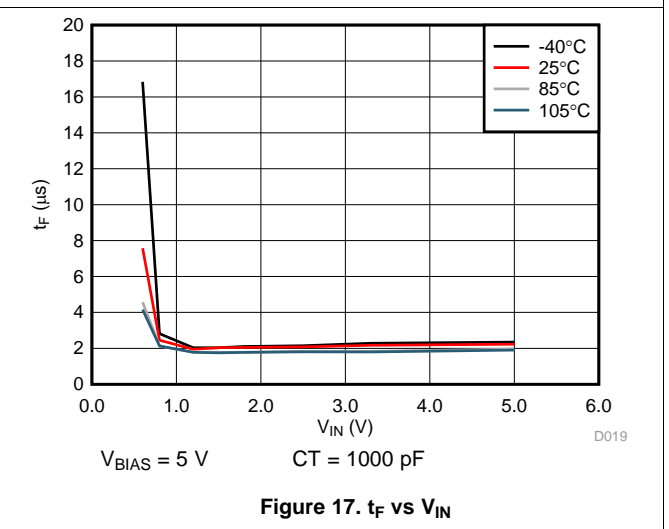
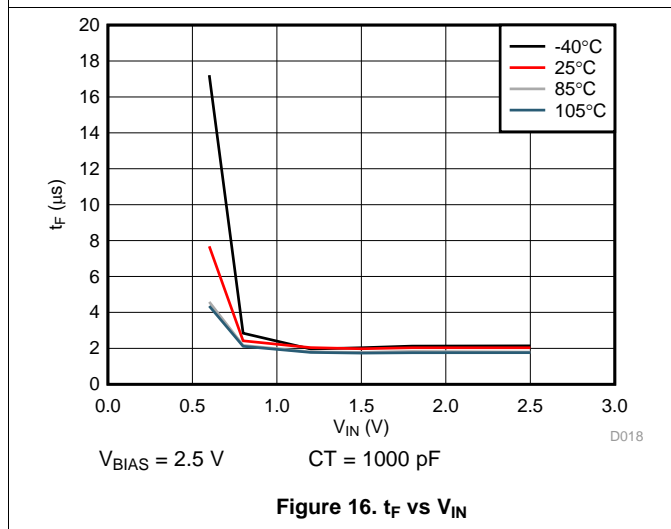
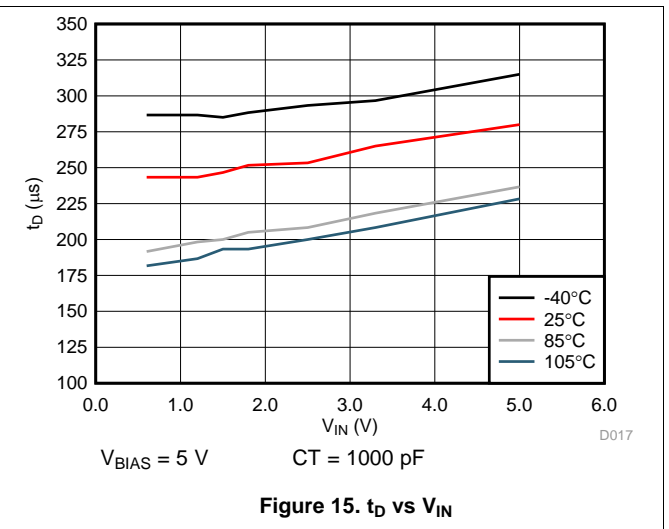
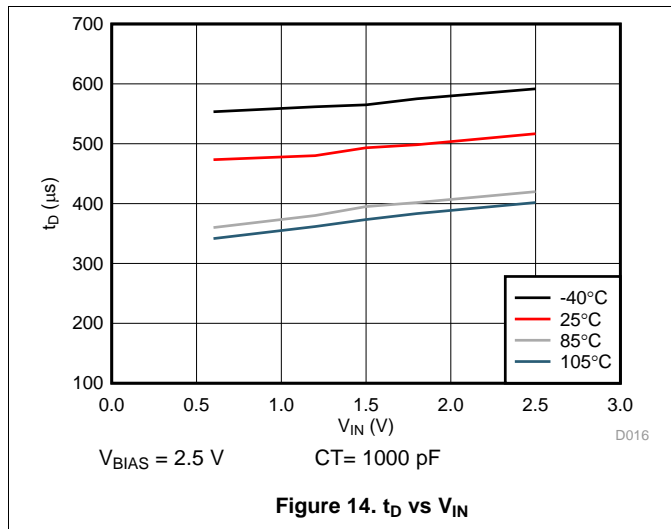
Figure 12. R_{PD} vs V_{BIAS}

Typical DC Characteristics (continued)

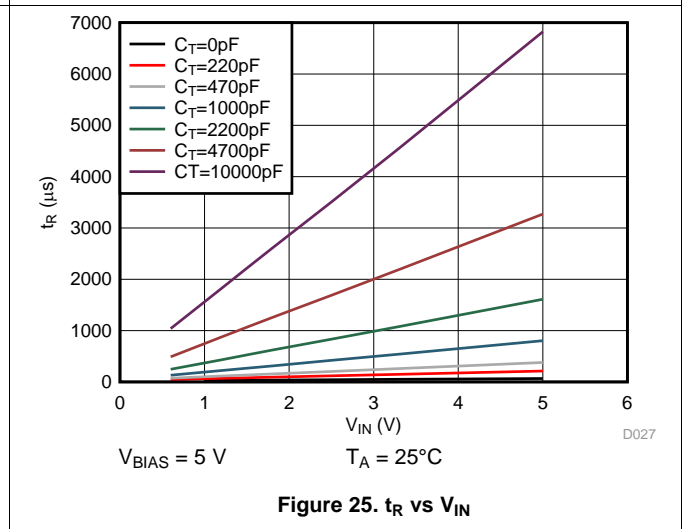
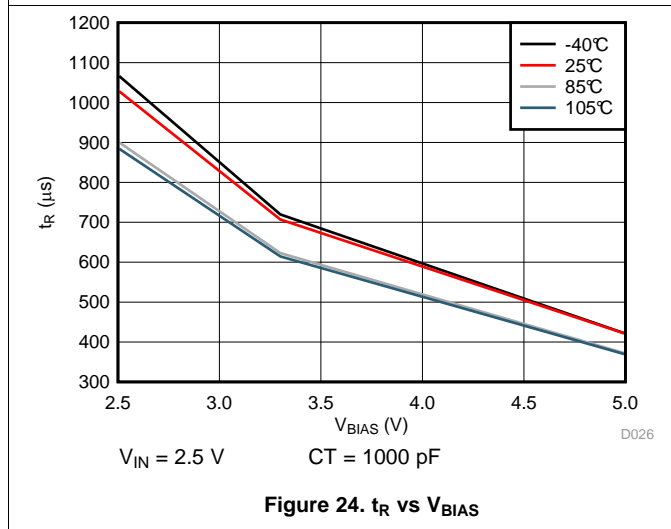
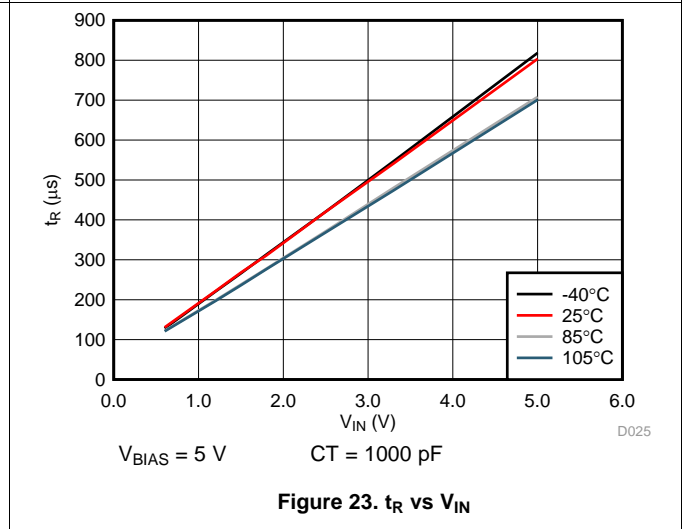
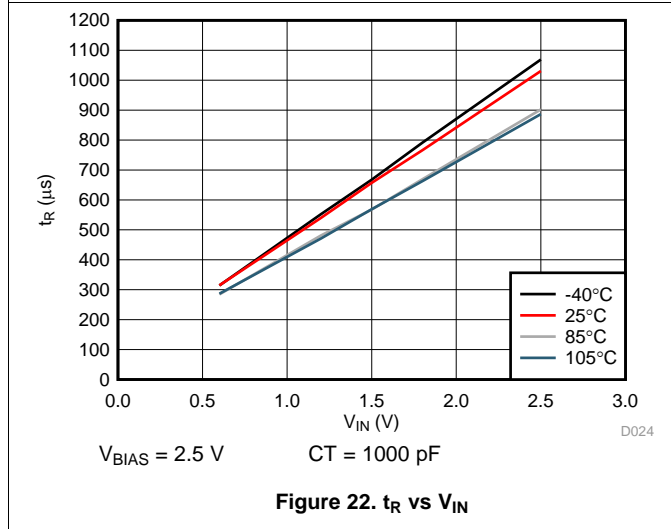
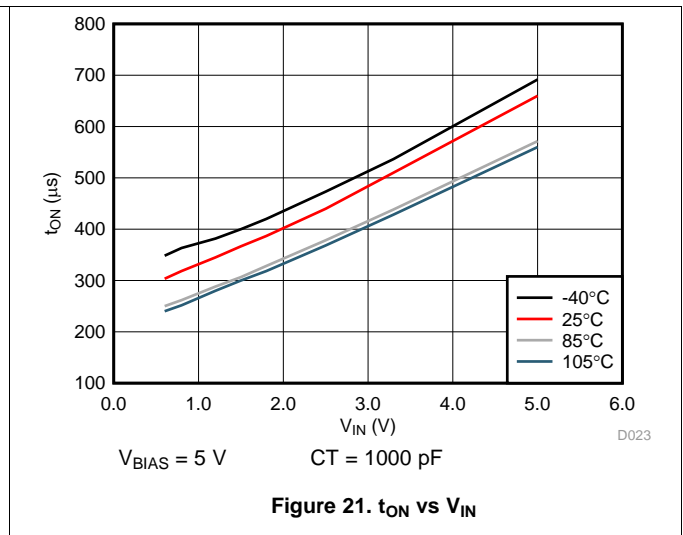
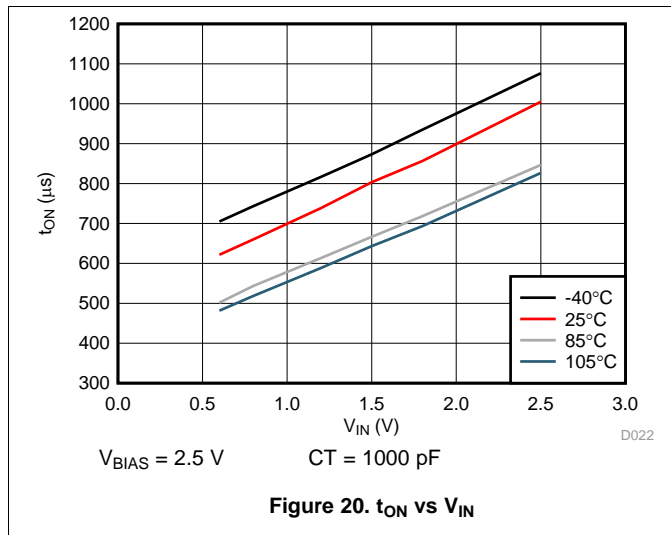


7.10 Typical AC Characteristics

$C_{IN} = 1 \mu F$, $C_L = 0.1 \mu F$, $R_L = 10 \Omega$ (unless otherwise specified)



Typical AC Characteristics (continued)



Typical AC Characteristics (continued)

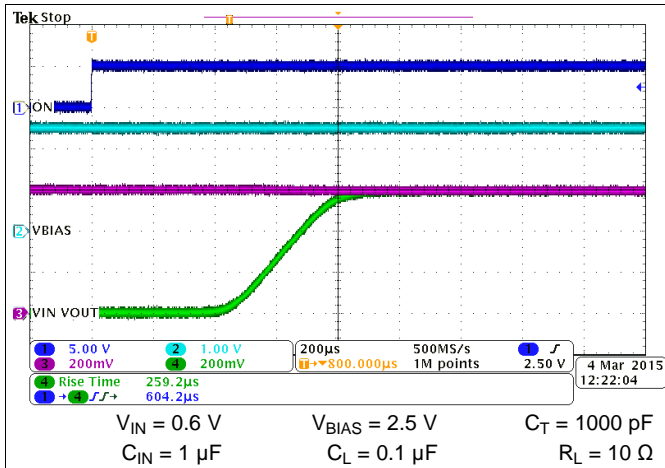


Figure 26. Turn-on Response Time

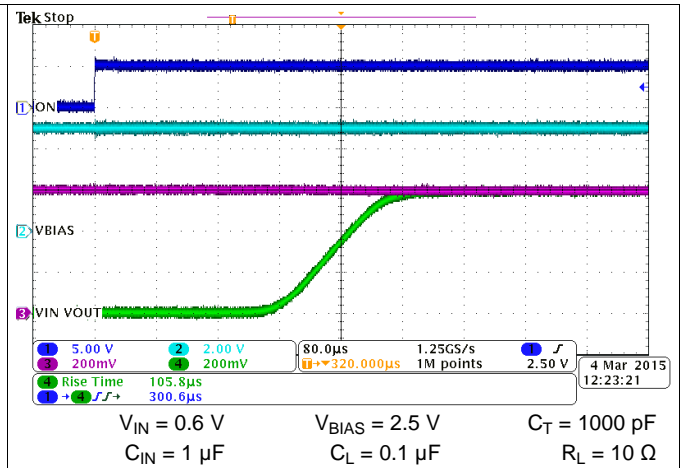


Figure 27. Turn-on Response Time

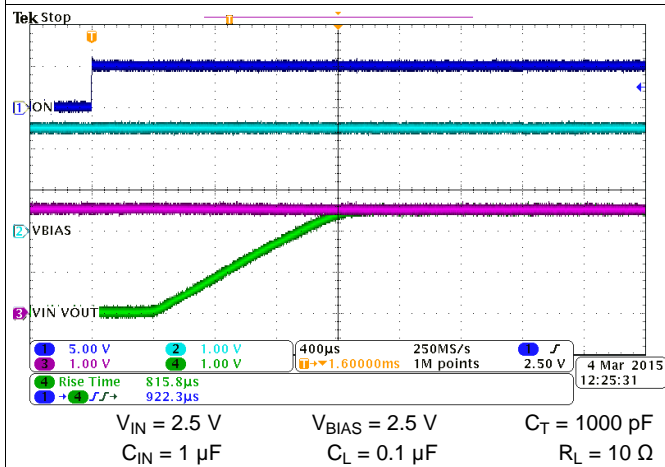


Figure 28. Turn-on Response Time

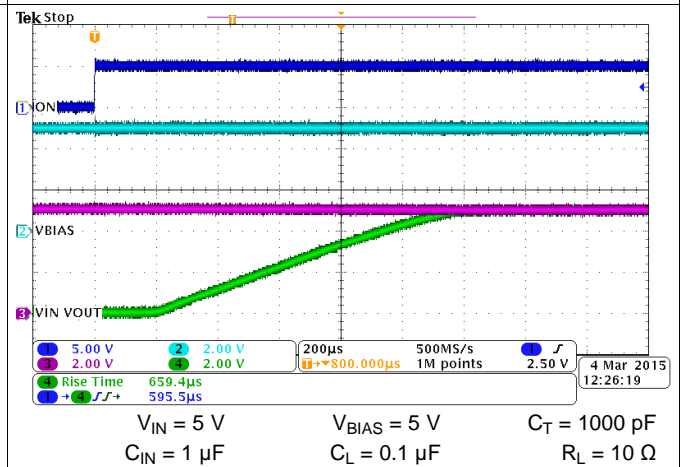


Figure 29. Turn-on Response Time

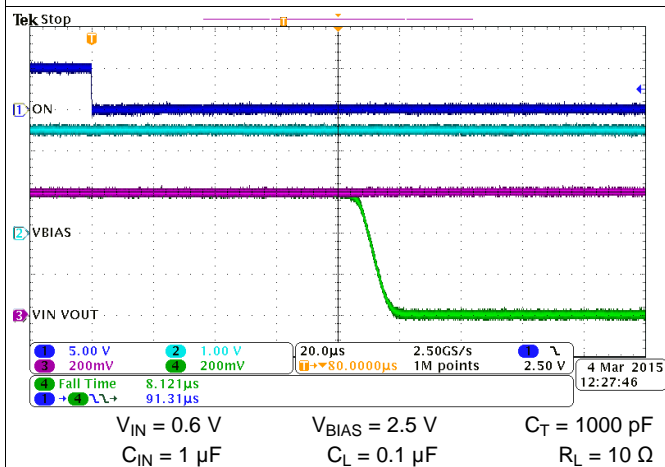


Figure 30. Turn-Off Response Time

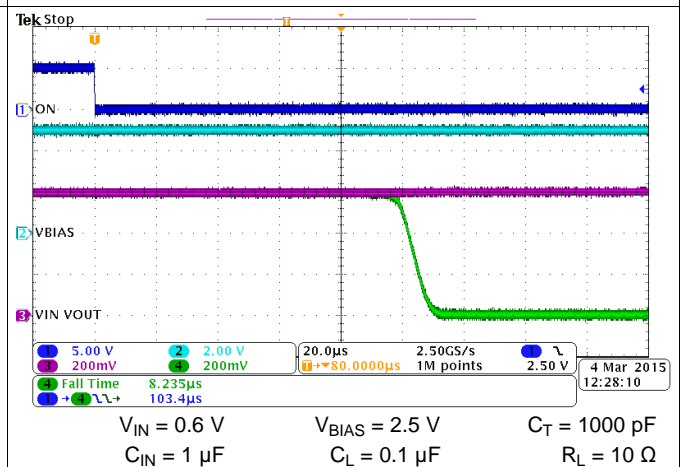
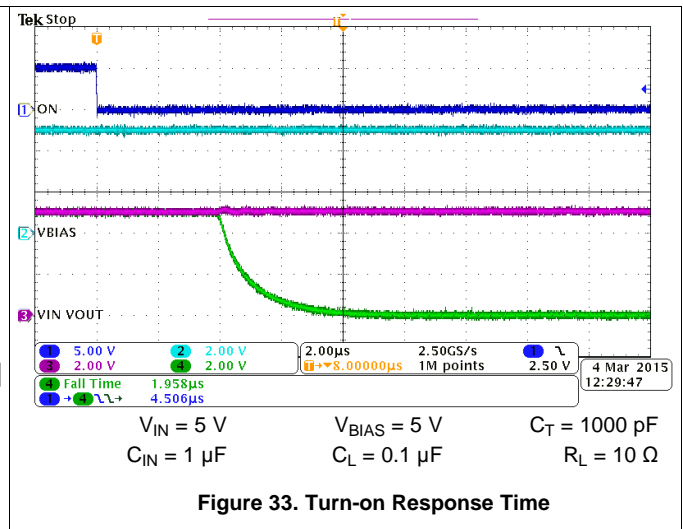
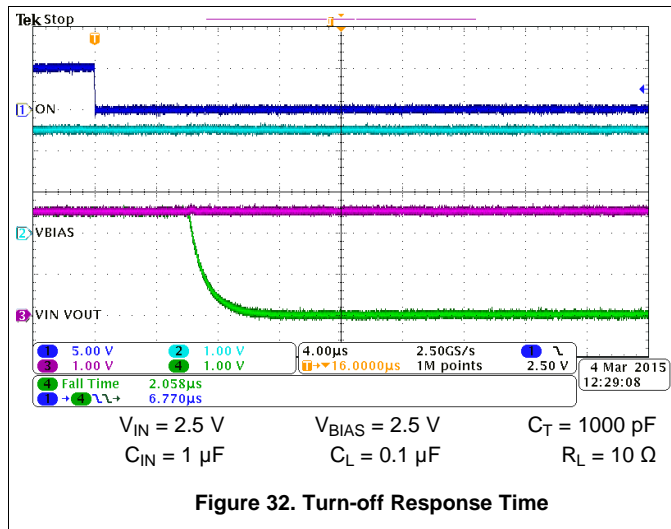
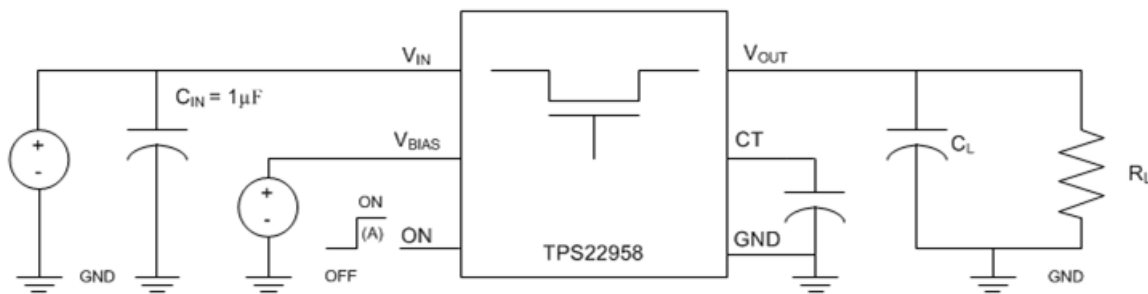


Figure 31. Turn-off Response Time

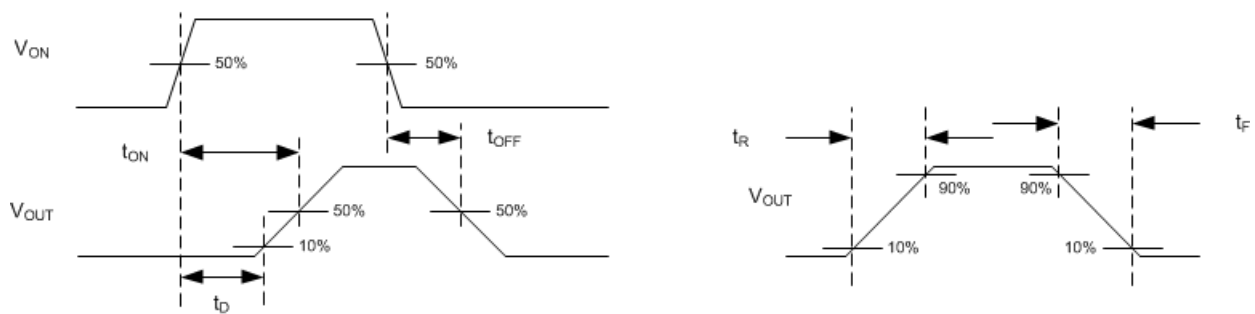
Typical AC Characteristics (continued)



8 Parameter Measurement Information



Timing test circuit



Timing waveforms

(A) Rise and fall times of the control signal is 100ns.

Figure 34. Test Circuit and Timing Waveforms

9 Detailed Description

9.1 Overview

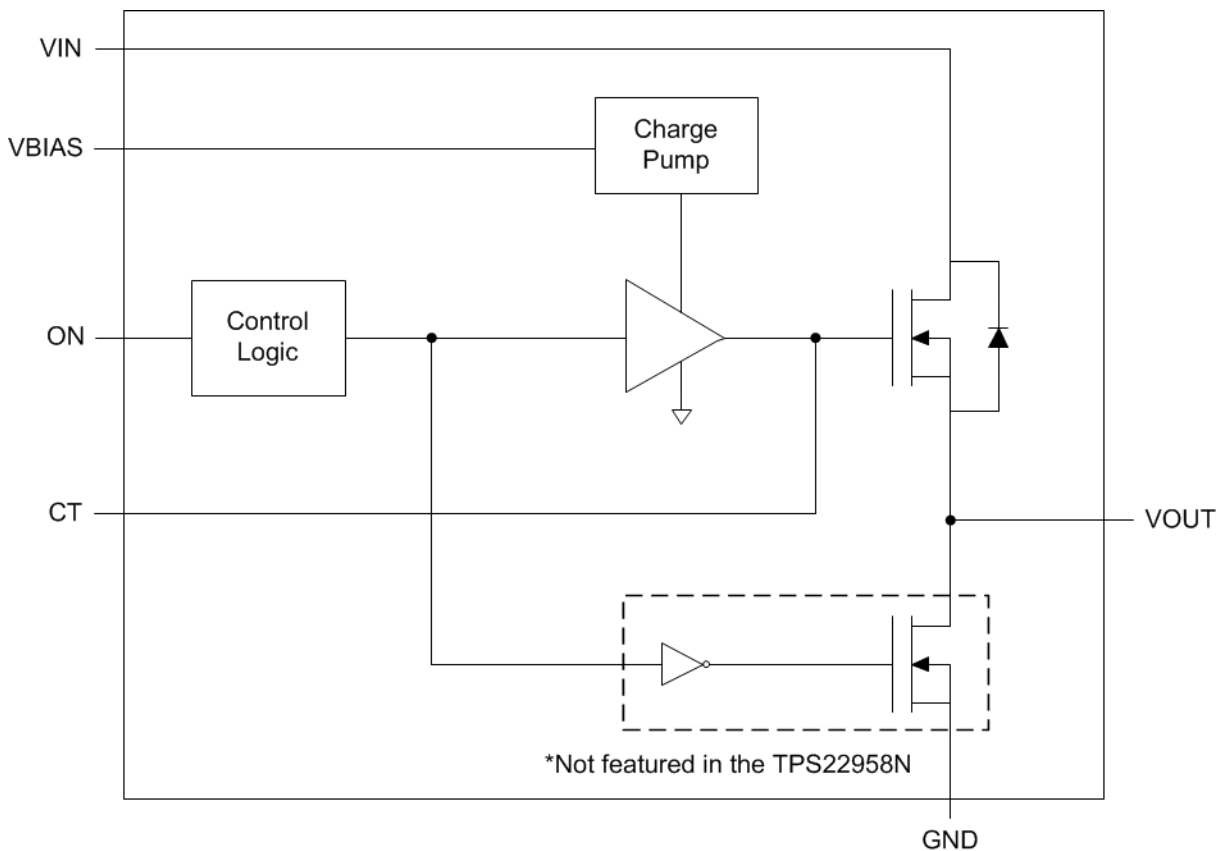
This device is a 5.5 V, 4 A / 6 A, single channel load switch with an adjustable rise time. The device contains an N-channel MOSFET controlled by an on/off GPIO-compatible input. The ON pin must be connected and cannot be left floating. The device is designed to control the turn-on rate and therefore the inrush current. By controlling the inrush current, power supply sag can be reduced during turn on. The slew rate is set by connecting a capacitor from the CT pin to GND.

The slew rate is proportional to the capacitor on the CT pin. Refer to the [Adjustable Rise Time](#) section to determine the correct CT value for a desired rise time.

The internal circuitry is powered by the VBIAS pin, which supports voltages from 2.5 to 5.5 V. This circuitry includes the charge pump, QOD, and control logic. For these internal blocks to function correctly, a voltage between 2.5 and 5.5 V must be supplied to VBIAS.

When a voltage is supplied to VBIAS and the ON pin goes low, the QOD turns on. This connects VOUT to GND through an on-chip resistor and is not a feature for the TPS22958N. The typical pull-down resistance (R_{PD}) is 135 Ω .

9.2 Functional Block Diagram



9.3 Feature Description

9.3.1 ON/OFF Control

The ON pin controls the state of the switch. Asserting ON high enables the switch. ON is active high and has a low threshold, making it capable of interfacing with low-voltage signals. The ON pin is compatible with standard GPIO logic threshold. It can be used with any microcontroller with 1.2 V or higher GPIO voltage. This pin cannot be left floating and must be tied either high or low for proper functionality.

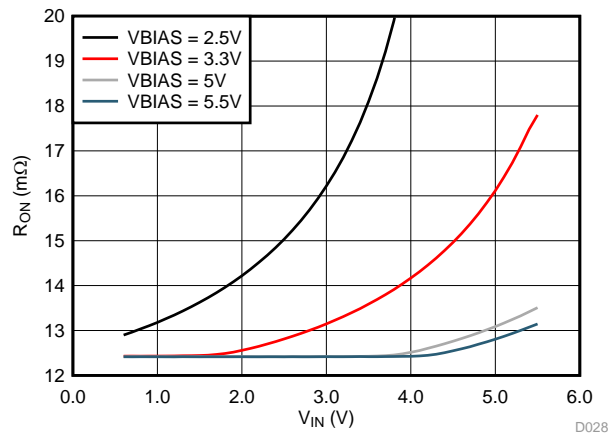
Feature Description (continued)

9.3.2 Quick Output Discharge (QOD)

The TPS22958 includes a QOD feature while the TPS22958N does not. When the device is disabled, a discharge resistor is connected between V_{OUT} and GND. This resistor has a typical value of 135 Ω and prevents the output from floating while the switch is disabled.

9.3.3 V_{IN} and V_{BIAS} Voltage Range

For optimal R_{ON} performance, make sure V_{IN} ≤ V_{BIAS}. The device will still function if V_{IN} > V_{BIAS} but will exhibit an R_{ON} greater than what is listed in the Electrical Characteristics table. See [Figure 35](#) for an example of a typical device. R_{ON} increases as V_{IN} exceeds the V_{BIAS} voltage. For the maximum voltage ratings on the V_{IN} and V_{BIAS} pins, please refer to the [Absolute Maximum Ratings](#) table.



T_A = 25°C I_{OUT} = -200 mA V_{ON} = 5 V

Figure 35. R_{ON} vs V_{IN}

Feature Description (continued)

9.3.4 Adjustable Rise Time

A capacitor from the CT pin to GND sets the slew rate, and it should be rated for 25 V and above. An approximate formula for the relationship between CT and slew rate with $V_{BIAS} = 5\text{ V}$ is:

$$SR = 0.146 \times CT + 14.78$$

where

- SR = slew rate (in $\mu\text{s/V}$)
- CT = the capacitance value on the CT pin (in pF)
- The units for the constant 14.78 is $\mu\text{s/V}$.
- The units for the constant 0.146 is $\mu\text{s}/(\text{V}\times\text{pF})$ (1)

Rise time can be calculated by multiplying the input voltage by the slew rate. [Table 1](#) contains rise time values measured on a typical device.

Table 1. Rise Time Table

CTx (pF)	RISE TIME (μs) 10% - 90%, $C_L = 0.1\ \mu\text{F}$, $C_{IN} = 1\ \mu\text{F}$, $R_L = 10\ \Omega$, $V_{BIAS} = 5\ \text{V}$ Typical values at 25°C with a 25-V X7R 10% ceramic capacitor on CT						
	VIN = 5 V	VIN = 3.3 V	VIN = 1.8 V	VIN = 1.5 V	VIN = 1.2 V	VIN = 0.8 V	VIN = 0.6 V
0	79	59	41	37	33	26	23
220	227	158	97	86	74	55	48
470	397	270	160	139	116	88	72
1000	769	522	301	258	211	153	126
2200	1659	1118	640	548	450	315	256
4700	3445	2314	1315	1128	927	656	528
10000	7310	4884	2778	2372	1950	1379	1103

9.4 Device Functional Modes

The following table lists the VOUT pin connections for a particular device as determined by the ON pin.

Table 2. VOUT Functional Table

ON (Control Input)	TPS22958	TPS22958N
L	GND	Open
H	VIN	VIN

10 Application and Implementation

10.1 Application Information

10.1.1 Input Capacitor (Optional)

To limit the voltage drop on the input supply caused by transient inrush currents when the switch turns on into a discharged load capacitor, a capacitor can be placed between VIN and GND. A 1 μF ceramic capacitor, C_{IN} , placed close to the pins, is usually sufficient. Higher values of C_{IN} can be used to further reduce the voltage drop during high-current application. When switching heavy loads, TI recommends to have an input capacitor about 10x higher than the output capacitor to avoid excessive voltage drop.

10.1.2 Output Capacitor (Optional)

Due to the integrated body diode in the NMOS switch, TI recommends a C_{IN} greater than C_{L} . A C_{L} greater than C_{IN} can cause the voltage on VOUT to exceed VIN when the system supply is removed. This could result in current flow through the body diode from VOUT to VIN. TI recommends a C_{IN} to C_{L} ratio of 10 to 1 for minimizing V_{IN} dip caused by inrush currents during startup.

10.1.3 Power Supply Sequencing Without a GPIO Input

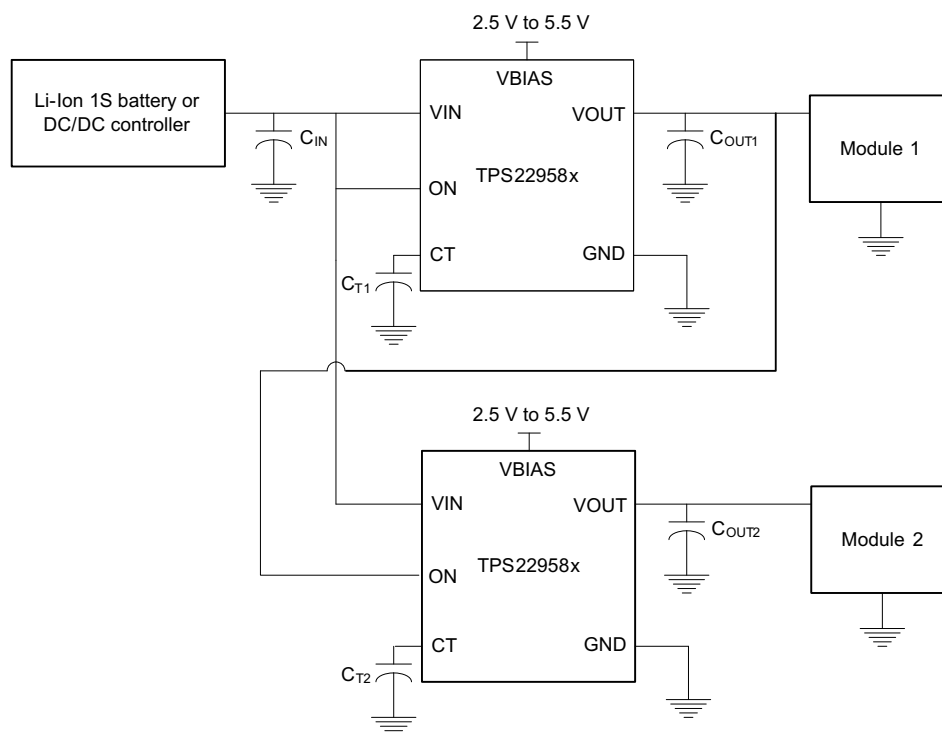


Figure 36. Power Supply Sequencing Without a GPIO Input

In many end equipments, there is a need to power up various modules in a pre-determined manner. The TPS22958x can solve the problem of power sequencing without adding any complexity to the overall system. [Figure 36](#) shows the configuration required for powering up two modules in a fixed sequence. The output of the first load switch is tied to the enable of the second load switch, so when Module 1 is powered the second load switch is enabled and Module 2 is powered.

10.2 Typical Application

This application demonstrates how the TPS22958 can be used to power a downstream load with a large capacitance. The example in Figure 37 is powering a 22 μF capacitive output load.

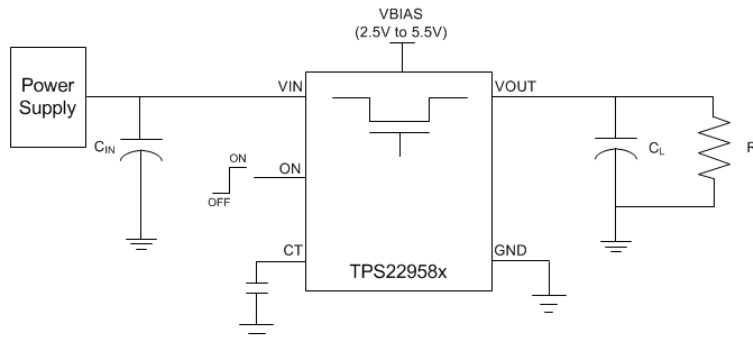


Figure 37. Typical Application Schematic

10.2.1 Design Requirements

For this design example, use the following as the input parameters.

Table 3. Design Parameters

DESIGN PARAMETER	EXAMPLE VALUE
V_{IN}	3.3 V
V_{BIAS}	5.0 V
Load current	4 A
Output capacitance (C_L)	22 μF
Allowable inrush current on VOUT	0.33 A

10.2.2 Detailed Design Procedure

To begin the design process, the designer needs to know the following:

- V_{IN} voltage
- V_{BIAS} voltage
- Load current
- Allowable inrush current on VOUT due to C_L capacitor

10.2.2.1 V_{IN} to V_{OUT} Voltage Drop

The V_{IN} to V_{OUT} voltage drop in the device is determined by the R_{ON} of the device and the load current. The R_{ON} of the device depends upon the V_{IN} and V_{BIAS} conditions of the device. Refer to the R_{ON} specification of the device in the Electrical Characteristics table. After the R_{ON} of the device is determined based upon the V_{IN} and V_{BIAS} conditions, use Equation 2 to calculate the V_{IN} to V_{OUT} voltage drop:

$$\Delta V = I_{LOAD} \times R_{ON}$$

where

- ΔV = voltage drop from V_{IN} to V_{OUT}
- I_{LOAD} = load current
- R_{ON} = On-resistance of the device for a specific V_{IN} and V_{BIAS} combination

(2)

An appropriate I_{LOAD} must be chosen such that the I_{MAX} specification of the device is not violated.

10.2.2.2 Inrush Current

To determine how much inrush current will be caused by the C_L capacitor, use [Equation 3](#).

$$I_{\text{INRUSH}} = C_L \times \frac{dV_{\text{OUT}}}{dt}$$

where

- I_{INRUSH} = amount of inrush caused by C_L
- C_L = capacitance on VOUT
- dt = time it takes for change in V_{OUT} during the ramp up of VOUT when the device is enabled
- dV_{OUT} = change in V_{OUT} during the ramp up of VOUT when the device is enabled (3)

The device offers adjustable rise time for VOUT and allows the user to control the inrush current during turn-on through the CT pin. The appropriate rise time can be calculated using the design requirements and the inrush current equation ([Equation 3](#)).

$$330 \text{ mA} = 22 \text{ } \mu\text{F} \times 3.3 \text{ V} / dt \quad (4)$$

$$dt = 22 \text{ } \mu\text{F} \times 3.3 \text{ V} / 300\text{mA} \quad (5)$$

$$dt = 220 \text{ } \mu\text{s} \quad (6)$$

To ensure an inrush current of less than 330 mA, choose a CT based on [Table 1](#) or [Equation 1](#) value that will yield a rise time of more than 220 μs . See the oscilloscope captures in the [Application Curves](#) for an example of how the CT capacitor can be used to reduce inrush current. See [Table 1](#) for correlation between rise times and CT values.

An appropriate C_L value should be placed on VOUT such that the I_{MAX} and I_{PLS} specifications of the device are not violated.

10.2.2.3 Thermal Considerations

The maximum IC junction temperature should be restricted to 125°C under normal operating conditions. To calculate the maximum allowable dissipation, $P_{\text{D(max)}}$ for a given output current and ambient temperature, use [Equation 7](#).

$$P_{\text{D(MAX)}} = \frac{T_{\text{J(MAX)}} - T_{\text{A}}}{R_{\theta\text{JA}}}$$

where

- $P_{\text{D(max)}}$ = maximum allowable power dissipation
- $T_{\text{J(max)}}$ = maximum allowable junction temperature (125°C for the TPS22958)
- T_{A} = ambient temperature of the device
- $R_{\theta\text{JA}}$ = junction to air thermal impedance. See [Thermal Information](#). This parameter is highly dependent upon board layout. (7)

For the DGK package, $V_{\text{BIAS}} = 5 \text{ V}$, and $V_{\text{IN}} = 3.3 \text{ V}$, the maximum ambient temperature with a 4 A load can be determined by using the following calculation:

$$P_{\text{D}} = I^2 \times R \quad (8)$$

$$T_{\text{A}} = T_{\text{J(MAX)}} - R_{\theta\text{JA}} \times P_{\text{D}} \quad (9)$$

$$T_{\text{A}} = T_{\text{J(MAX)}} - R_{\theta\text{JA}} \times I^2 \times R \quad (10)$$

$$T_{\text{A}} = 125^\circ\text{C} - 185.7^\circ\text{C/W} \times (4 \text{ A})^2 \times 20 \text{ m}\Omega = 65.6^\circ\text{C} \quad (11)$$

Therefore, with the conditions mentioned above, a maximum ambient temperature of 65.6°C is recommended.

For the DGN package, $V_{BIAS} = 5\text{ V}$, and $V_{IN} = 3.3\text{ V}$, the maximum ambient temperature with a 4 A load can be determined by using the following calculation:

$$P_D = I^2 \times R \tag{12}$$

$$T_A = T_{J(MAX)} - R_{\theta JA} \times P_D \tag{13}$$

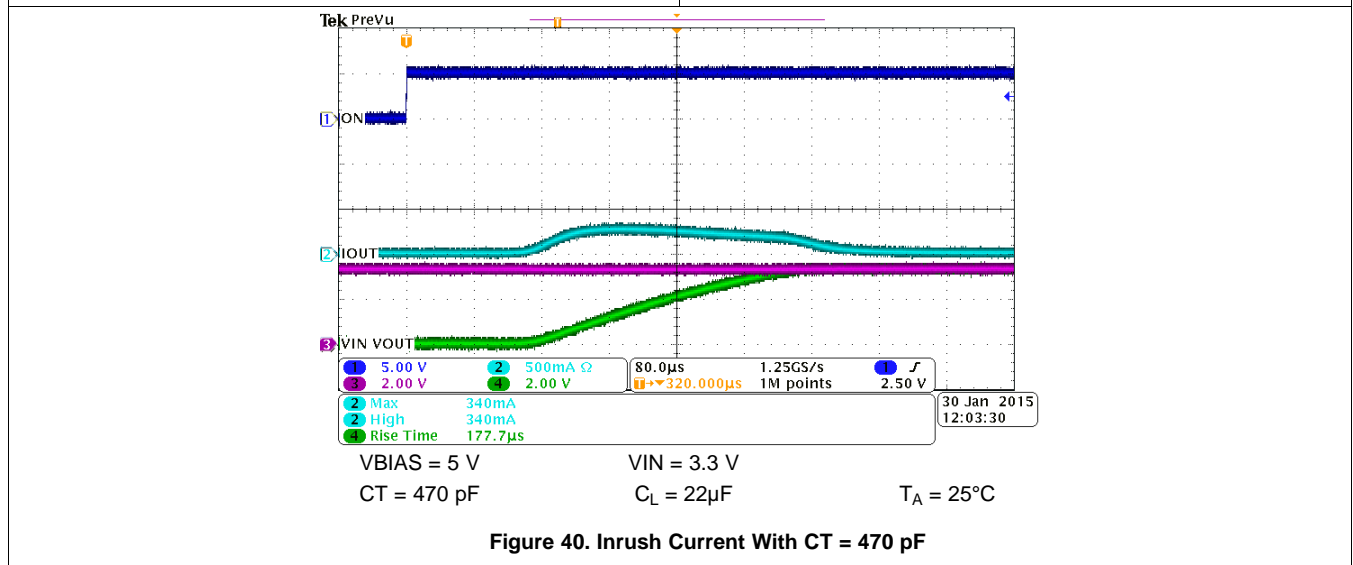
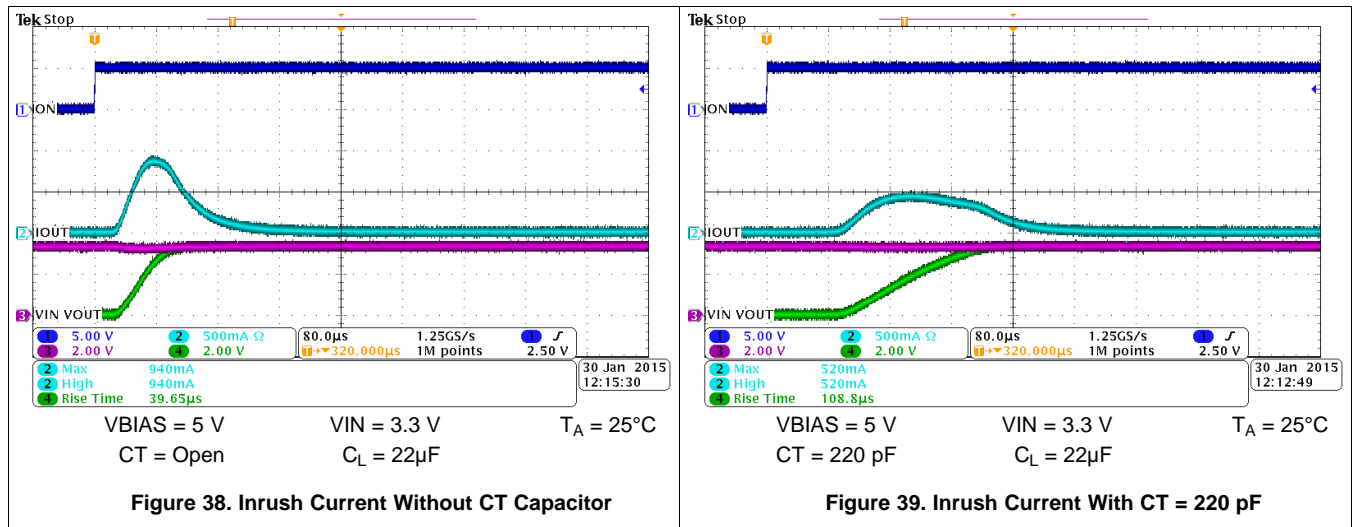
$$T_A = T_{J(MAX)} - R_{\theta JA} \times I^2 \times R \tag{14}$$

$$T_A = 125^\circ\text{C} - 67.0^\circ\text{C/W} \times (4\text{ A})^2 \times 20\text{ m}\Omega = 103.6^\circ\text{C} \tag{15}$$

Therefore, with the conditions mentioned above, a maximum ambient temperature of 103.6°C is recommended.

10.2.3 Application Curves

The three scope captures show the usage of a CT capacitor in conjunction with the device. A higher CT value results in a slower rise and a lower inrush current.



11 Power Supply Recommendations

The device is designed to operate from a V_{BIAS} range of 2.5 to 5.5 V and V_{IN} range of 0.6 to 5.5 V. The power supply should be well regulated and placed as close to the device terminals as possible. It must be able to withstand all transient and load current steps. In most situations, using the minimum recommended input capacitance of 1 μ F is sufficient to prevent the supply voltage from dipping when the switch is turned on. In cases where the power supply is slow to respond to a large transient current or large load current step, additional bulk capacitance may be required on the input. To avoid ringing on the VBIAS pin from a noisy power supply, a bypass capacitance of 0.1 μ F is recommended.

The requirements for large input capacitance can be mitigated by adding additional capacitance to the CT pin. This will cause the load switch to turn on more slowly. Not only will this reduce transient inrush current, but it will also give the power supply more time to respond to the load current step.

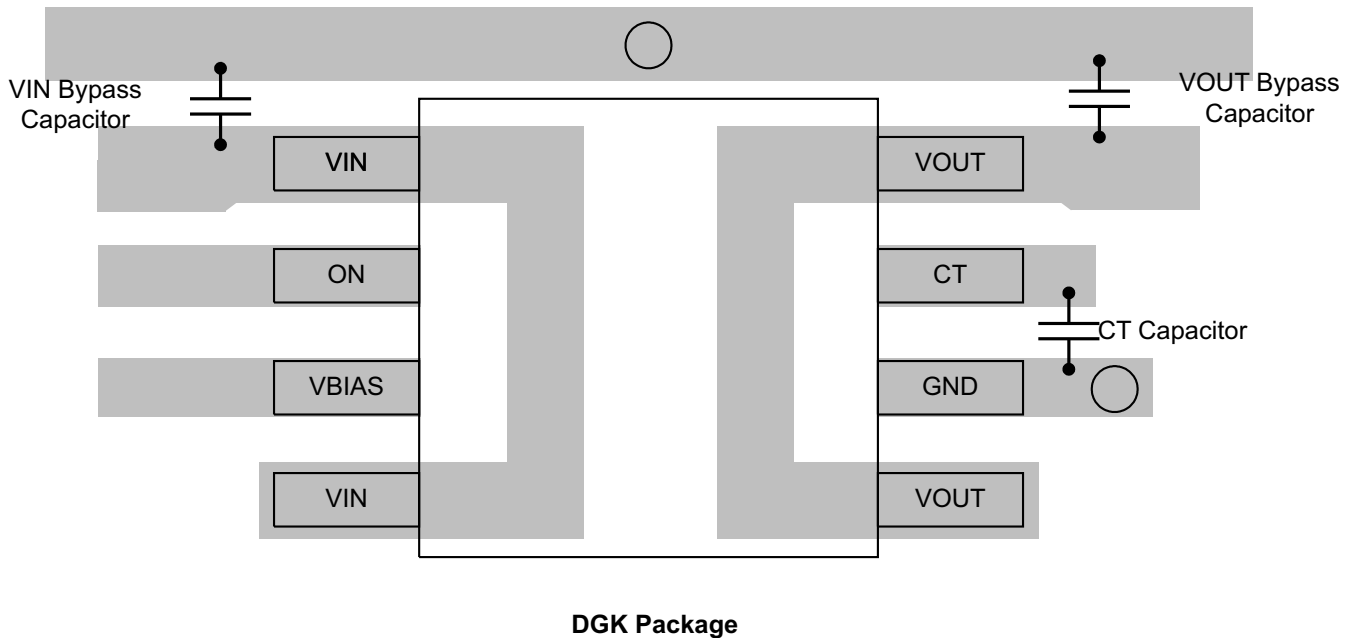
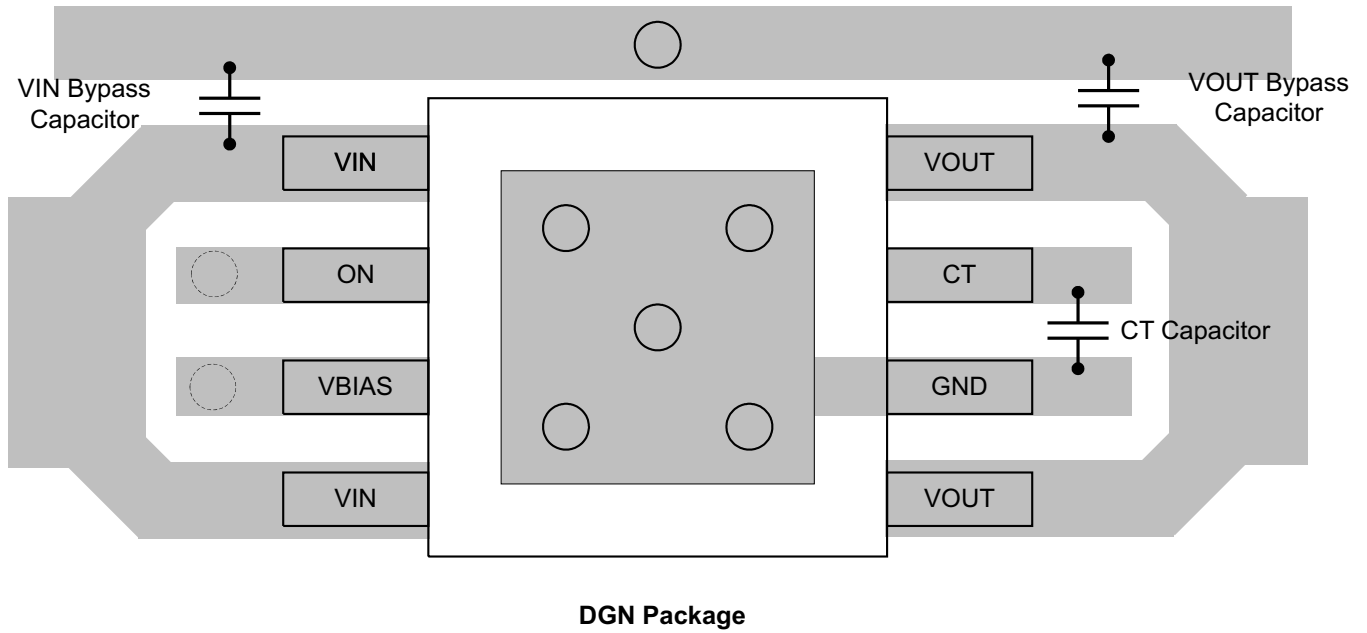
12 Layout

12.1 Layout Guidelines

- VIN and VOUT traces should be as short and wide as possible to accommodate for high current. When connecting the two VIN or VOUT pins together, an equal trace length should be used to avoid an unequal distribution of current through each pin.
- Use vias under the exposed thermal pad to connect to the power ground plane for thermal relief during high current operation.
- VIN pins should be bypassed to ground with low-ESR ceramic bypass capacitors. The typical recommended bypass capacitance is 1- μ F ceramic with X5R or X7R dielectric. This capacitor should be placed as close to the device pins as possible.
- VOUT pins should be bypassed to ground with low-ESR ceramic bypass capacitors. The typical recommended bypass capacitance is one-tenth of the VIN bypass capacitor of X5R or X7R dielectric rating. This capacitor should be placed as close to the device pins as possible.
- The CT capacitor should be placed as close to the device pins as possible. The typical recommended CT capacitance is a capacitor of X5R or X7R dielectric rating with a rating of 25 V or higher.

12.2 Layout Example

○ VIA to Power Ground Plane ○ VIA to another layer



13 Device and Documentation Support

13.1 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 4. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
TPS22958	Click here	Click here	Click here	Click here	Click here
TPS22958N	Click here	Click here	Click here	Click here	Click here

13.2 Trademarks

All trademarks are the property of their respective owners.

13.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

13.4 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TPS22958DGKR	PREVIEW	VSSOP	DGK	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAUAG	Level-1-260C-UNLIM	-40 to 105	ZBUX	
TPS22958DGNR	ACTIVE	MSOP-PowerPAD	DGN	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAUAG	Level-1-260C-UNLIM	-40 to 105	ZBVX	Samples
TPS22958NDGKR	PREVIEW	VSSOP	DGK	8	2500	TBD	Call TI	Call TI	-40 to 105	ZBWX	
TPS22958NDGNR	ACTIVE	MSOP-PowerPAD	DGN	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAUAG	Level-1-260C-UNLIM	-40 to 105	ZBXX	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSELETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

TAPE AND REEL INFORMATION



QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPS22958DGNR	MSOP-Power PAD	DGN	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
TPS22958NDGNR	MSOP-Power PAD	DGN	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1

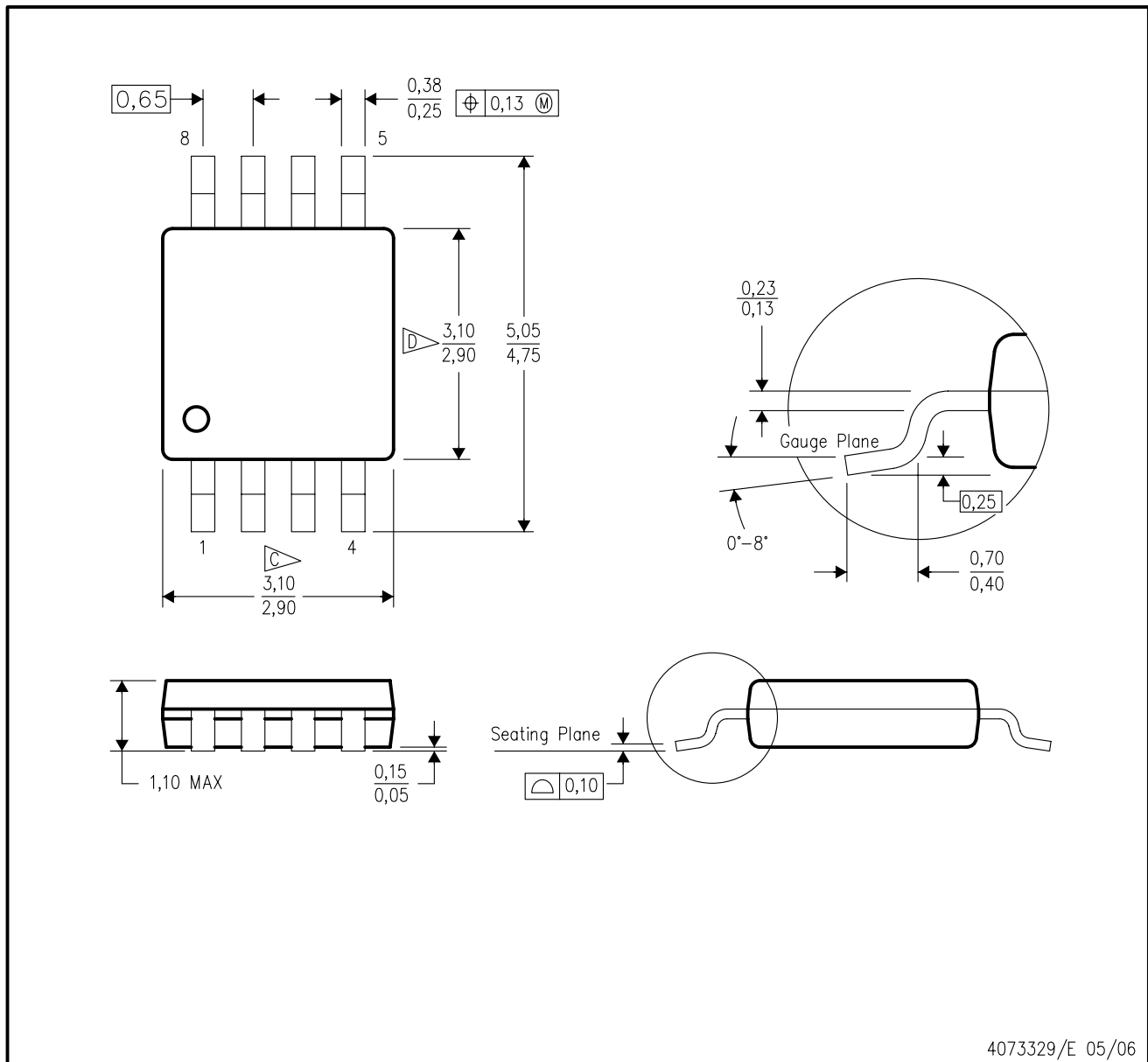
TAPE AND REEL BOX DIMENSIONS


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPS22958DGNR	MSOP-PowerPAD	DGN	8	2500	364.0	364.0	27.0
TPS22958NDGNR	MSOP-PowerPAD	DGN	8	2500	364.0	364.0	27.0

DGK (S-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



4073329/E 05/06

- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 per end.
 - D. Body width does not include interlead flash. Interlead flash shall not exceed 0.50 per side.
 - E. Falls within JEDEC MO-187 variation AA, except interlead flash.

DGN (S-PDSO-G8)

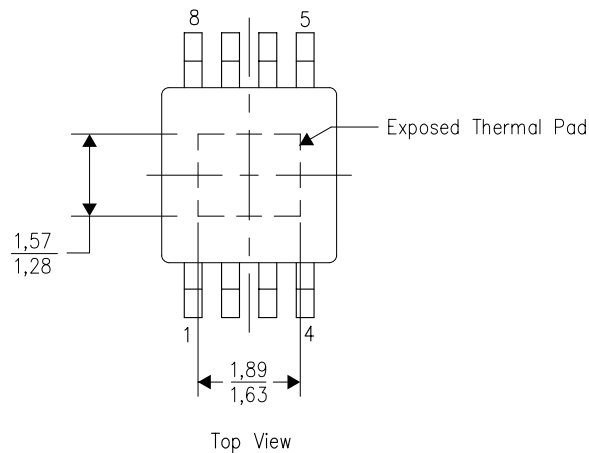
PowerPAD™ PLASTIC SMALL OUTLINE

THERMAL INFORMATION

This PowerPAD™ package incorporates an exposed thermal pad that is designed to be attached to a printed circuit board (PCB). The thermal pad must be soldered directly to the PCB. After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For additional information on the PowerPAD package and how to take advantage of its heat dissipating abilities, refer to Technical Brief, PowerPAD Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 and Application Brief, PowerPAD Made Easy, Texas Instruments Literature No. SLMA004. Both documents are available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.

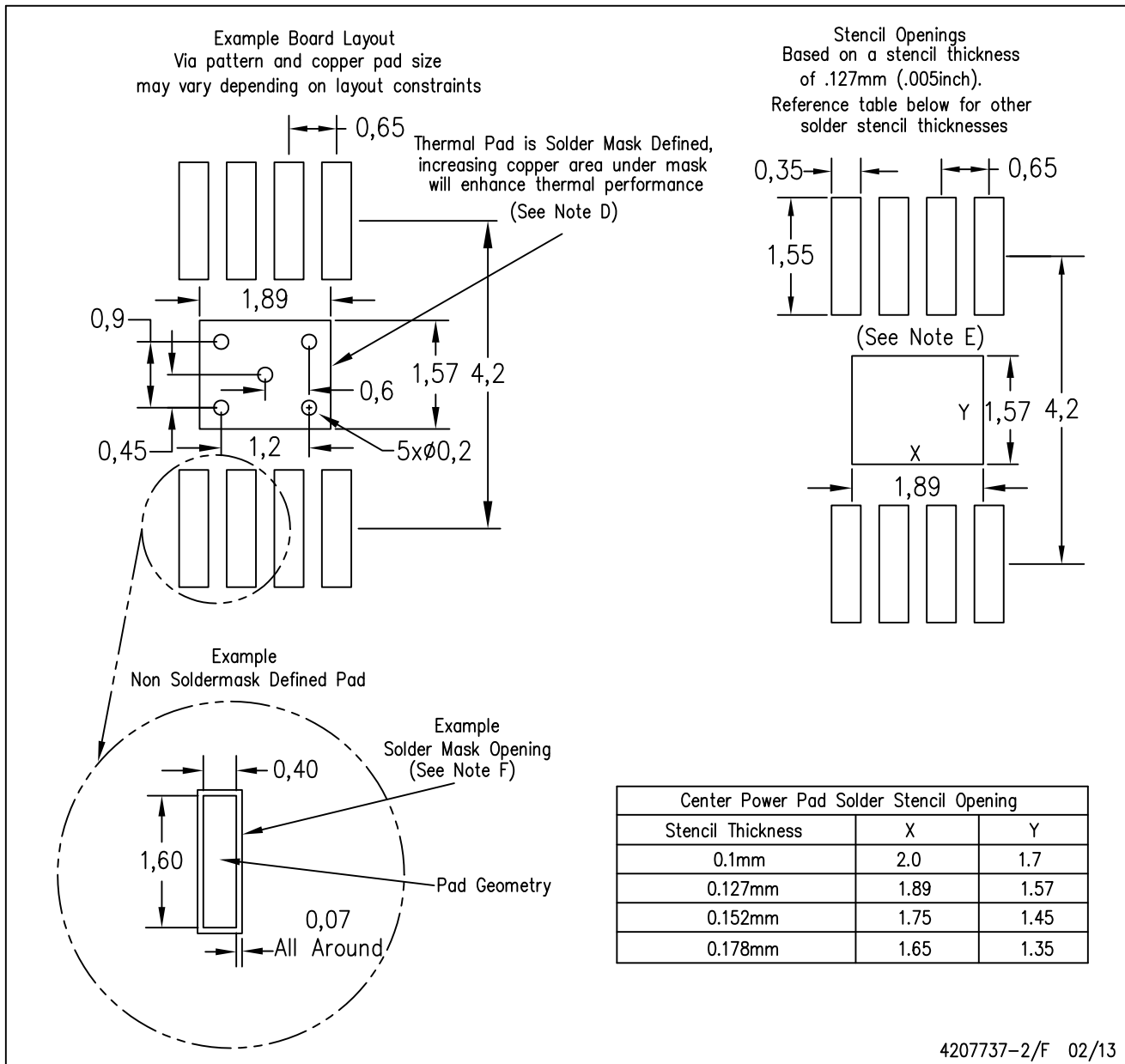


Exposed Thermal Pad Dimensions

4206323-2/1 12/11

NOTE: All linear dimensions are in millimeters

PowerPAD is a trademark of Texas Instruments



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
 - D. This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002, SLMA004, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <<http://www.ti.com>>.
 - E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.
 - F. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

PowerPAD is a trademark of Texas Instruments

IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have **not** been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

Products

Audio	www.ti.com/audio
Amplifiers	amplifier.ti.com
Data Converters	dataconverter.ti.com
DLP® Products	www.dlp.com
DSP	dsp.ti.com
Clocks and Timers	www.ti.com/clocks
Interface	interface.ti.com
Logic	logic.ti.com
Power Mgmt	power.ti.com
Microcontrollers	microcontroller.ti.com
RFID	www.ti-rfid.com
OMAP Applications Processors	www.ti.com/omap
Wireless Connectivity	www.ti.com/wirelessconnectivity

Applications

Automotive and Transportation	www.ti.com/automotive
Communications and Telecom	www.ti.com/communications
Computers and Peripherals	www.ti.com/computers
Consumer Electronics	www.ti.com/consumer-apps
Energy and Lighting	www.ti.com/energy
Industrial	www.ti.com/industrial
Medical	www.ti.com/medical
Security	www.ti.com/security
Space, Avionics and Defense	www.ti.com/space-avionics-defense
Video and Imaging	www.ti.com/video

TI E2E Community

e2e.ti.com